HP 4396A Network/Spectrum Analyzer User's Guide

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Safety Summary

The following general safety precautions must be observed during all phases of operation, service, and repair of this instrument. Failure to comply with these precautions or with specific *WARNINGS* given elsewhere in this manual violates safety standards of design, manufacture, and intended use of the instrument.

The Hewlett-Packard Company assumes no liability for the customer's failure to comply with these requirements.

Ground The Instrument

This is a Safety Class 1 product (provided with a protective earth terminal). An uninterruptible safety earth ground must be provided from the main power source to the product input wiring terminals, power source to the product input wiring terminals, power cord, or supplied power cord set. Whenever it is likely that the protection has been impaired, the product must be made inoperative and secured against any unintended operation.

DO NOT Operate in an Explosive Atmosphere

Do not operate the instrument in the presence of flammable gases or fumes. Operation of any electrical instrument in such an environment is a safety hazard.

Keep Away From Live Circuits

Operating personnel must not remove instrument covers. Component replacement and internal adjustments must be made by qualified maintenance personnel. Do not replace components with the power cable connected. Under certain conditions, dangerous voltages may exist even with the power cable removed. To avoid injuries, always disconnect power and discharge circuits before touching them.

DO NOT Service Or Adjust Alone

Do not attempt internal service or adjustment unless another person, capable of rendering first aid and resuscitation, is present.

DO NOT Substitute Parts Or Modify Instrument

Because of the danger of introducing additional hazards; do not substitute parts or perform unauthorized modifications to the instrument. Return the instrument to a Hewlett-Packard Sales and Service Office for service and repair to ensure the safety features are maintained.

Dangerous Procedure Warnings

Warnings, such as the example below, precede potentially dangerous procedures throughout this manual. Instructions contained in the warnings must be followed.

Warning



Dangerous voltages, capable of causing death, are present in this instrument. Use extreme caution when handling, testing, and adjusting this instrument.

Typeface Conventions

Bold

Boldface type is used when a term is defined. For example: icons are symbols.

Italics

Italic type is used for emphasis and for titles of manuals and other publications.

Italic type is also used for keyboard entries when a name or a variable must be typed in place of the words in italics. For example: copy *filename* means to type the word copy, to type a space, and then to type the name of a file such as file1.

Computer

Computer font is used for on-screen prompts and messages.

HARDKEYS

Labeled keys on the instrument front panel are enclosed in ().

SOFTKEYS

Softkeys located to the right of the CRT are enclosed in

Certification

Hewlett-Packard Company certifies that this product met its published specifications at the time of shipment from the factory. Hewlett-Packard further certifies that its calibration measurements are traceable to the United States National Institute of Standards and Technology, to the extent allowed by the Institution's calibration facility, or to the calibration facilities of other International Standards Organization members.

Warranty

This Hewlett-Packard instrument product is warranted against defects in material and workmanship for a period of one year from the date of shipment, except that in the case of certain components listed in *Instrument Specifications* of *Function Reference*, the warranty shall be for the specified period. During the warranty period, Hewlett-Packard Company will, at its option, either repair or replace products which prove to be defective.

For warranty service or repair, this product must be returned to a service facility designated by HP. Buyer shall prepay shipping charges to HP and HP shall pay shipping charges to return the product to Buyer. However, Buyer shall pay all shipping charges, duties, and taxes for products returned to HP from another country.

HP warrants that software and firmware designated by HP for use with an instrument will execute its programming instruction when property installed on that instrument. HP does not warrant that the operation of the instrument, or software, or firmware will be uninterrupted or error free.

Limitation of Warranty

The foregoing warranty shall not apply to defects resulting from improper or inadequate maintenance by Buyer, Buyer-supplied software or interfacing, unauthorized modification or misuse, operation outside of the environmental specifications for the product, or improper site preparation or maintenance.

No other warranty is expressed or implied. HP specifically disclaims the implied warranties of merchantability and fitness for a particular purpose.

Exclusive Remedies

The remedies provided herein are buyer's sole and exclusive remedies. HP shall not be liable for any direct, indirect, special, incidental, or consequential damages, whether based on contract, tort, or any other legal theory.

Assistance

Product maintenance agreements and other customer assistance agreements are available for Hewlett-Packard products.

For any assistance, contact your nearest Hewlett-Packard Sales and Service Office. Addresses are provided at the back of this manual.

Safety Symbols

General definitions of safety symbols used on equipment or in manuals.



Instruction manual symbol: the product is marked with this symbol when it is necessary for the user to refer to the instruction manual in order to protect against damage to the instrument.



Indicates dangerous voltage (terminals fed from the interior by voltage exceeding 1000 volts must be so marked).



Protective conductor terminal. For protection against electrical shock in case of a fault. Used with wiring terminals to indicate the terminal which must be connected to ground before operating equipment.



Low-noise or noiseless, clean ground (earth) terminal. Used for a signal common, as well as providing protection against electrical shock in case of fault. A terminal marked with this symbol must be connected to ground in the manner described in the installation (Operation) manual, and before operating the equipment.



Frame or chassis terminal. A connection to the frame (chassis) of the equipment which normally includes all exposed metal structures.



Alternating current (power line).



Direct current (power line).



Alternating or direct current (power line).





Warning denotes a hazard. It calls attention to a procedure, practice, condition or the like, which, if not correctly performed or adhered to, could result in injury or death to personnel.

Caution



Caution denotes a hazard. It calls attention to a procedure, practice, condition or the like, which, if not correctly performed or adhered to, could result damage to or destruction of part or all of the product.

Note



Note denotes important information. It calls attention to a procedure, practice, condition or the like, which is essential to highlight.

How To Use This Manual

This is a user's guide for the HP 4396A Network/Spectrum Analyzer. This manual contains two quick start tours, measurement examples, an installation and setup guide and a table that tells you where to find more information.

Quick Start Tour

Chapters 1 and 2 provide step-by-step instructions for you if you are operating the analyzer for the first time. By performing these tours, you will become familiar with the basic operations of the analyzer. Chapter 1 is for the spectrum analyzer mode, and chapter 2 is for the network analyzer mode.

Measurement Examples

Chapters 3 and 4 provide how to use the analyzer for typical network and spectrum measurement. Chapter 3 contains measurement examples of spectrum measurement applications, and chapter 4 contains examples of network measurement applications.

Installation and Setup Guide

Appendix A provides installation information that includes an initial inspection, power line setting, test-set setup, and keyboard connection. If you do not prepare the analyzer yet, read this section first.

For More Information

Appendix B provides a table that helps you find the information you need in the documentation set.

Microfiche Copies of the Manual

Use the microfiche part number on the title page to order a package of 10×15 centimeter (4×6 inch) microfilm transparencies of this manual, the *User's Guide*, the *Task Reference*, the *Function Reference*, the *HP-IB Programming Guide*, the *HP-IB Command Reference*, the *Using HP Instrument BASIC with the HP 4396A*, the *Performance Test Manual*, and the *Service Manual*.

Documentation Map

The following manuals are available for the analyzer.

User's Guide (HP Part Number 04396-90001)

The User's Guide walks you through system setup and initial power-on, shows how to make basic measurements, explains commonly used features, and typical application measurement examples. After you receive your analyzer, begin with this manual.

Task Reference (HP Part Number 04396-90000)

Task Reference helps you to learn how to use the analyzer. This manual provides simple step-by-step instructions without concepts.

Function Reference (HP Part Number 04396-90002)

The Function Reference describes all function accessed from the front panel keys and softkeys. It also provides information on options and accessories available, specifications, system performance, and some topics about the analyzer's features.

Programming Guide (HP Part Number 04396-90003)

The Programming Guide shows how to write and use BASIC program to control the analyzer.

HP-IB Command Reference (HP Part Number 04396-90004)

The HP-IB Command Reference provides a summary of all available HP-IB commands. It also provides information on the status reporting structure and the trigger system (these features conform to the SCPI standard).

Using HP Instrument BASIC with the HP 4396A (Option 1C2 only) (HP Part Number 04396-90005)

The Using HP Instrument BASIC with the HP 4396A describes how HP Instrument BASIC works with the analyzer.

HP Instrument BASIC Manual Set (Option 1C2 only), (HP Part Number E2083-90000)

The HP Instrument BASIC User's Handbook introduces you to the HP Instrument BASIC programming language, provide some helpful hints on getting the most use from it, and provide a general programming reference. It is divided into three books, HP Instrument BASIC Programming Techniques, HP Instrument BASIC Interface Techniques, and HP Instrument BASIC Language Reference.

Performance Test Manual (HP Part Number 04396-90100)

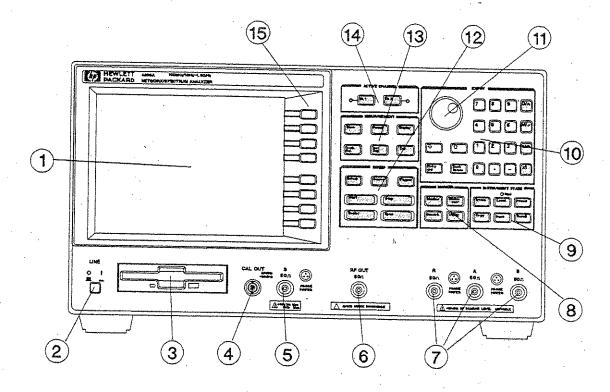
The Performance Test Manual explains how to verify conformance to published specifications.

Service Manual (Option 0BW only), (HP Part Number 04396-90101)

The Service Manual explains how to adjust, troubleshoot, and repair the instrument. This manual is option 0BW only.

The Analyzer at a Glance

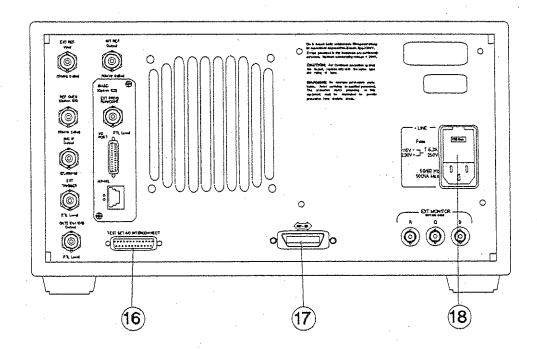
Front View



- 1. CRT displays measured results, softkey menus, current settings, system messages, error messages, and Instrument BASIC programs.
- 2. LINE switch turns the analyzer ON and OFF.
- 3. 3.5 inch disk drive is used to store measurement results, instrument settings, display images, and Instrument BASIC programs.
- 4. CAL OUT (spectrum analyzer calibration output port) supplies a reference signal (20 MHz, -20 dbm) for reference level calibration.
- 5. S input (spectrum analyzer input) receives a signal for a spectrum measurement.
- 6. RF OUT (RF signal output port) supplies a source signal for network measurements.
- 7. R, A, and B inputs (RF signal inputs) mainly accept signals for network measurements, but can also be used as spectrum measurement inputs.
- 8. MARKER block contains keys related to the marker functions.
- 9. **INSTRUMENT STATE block** contains keys related to setting analyzer functions.

- 10. ENTRY block contains numerical keys, rotary knob, increment/decrement keys, edit keys, and unit-terminator keys.
- 11. Rotary knob changes displayed value by turning the knob.
- 12. SWEEP block contains keys related to the sweep functions.
- 13. **MEASUREMENT block** controls the measurement and display functions.
- 14. ACTIVE CHANNEL block selects the active channel as 1 or 2.
- 15. **Softkeys** used with hierarchical menus that are displayed by pressing hardkeys. Pressing a softkey activates the displayed function or accesses a lower level menu.

Rear View



- 16. **TEST SET-I/O INTERCONNECT** connects the S-parameter test set to the analyzer.
- 17. **HP-IB** interface controls an HP-IB instrument or can be controlled by an external controller.
- 18. Power cable receptacle connects the power cable. Fuse and line voltage selector are held in the cover of the receptacle.

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Spectrum Analyzer Tour

In this chapter, you explore the spectrum analyzer mode of operation. Before starting this tour, verify the analyzer is correctly installed (see appendix A, "Installation and Setup Guide," if you need additional information).

Before You Leave On The Tour

On this tour, you will learn how to make a basic spectrum analyzer measurement by measuring the CAL OUT signal of the analyzer.

Overview

The following is a short summary of the tour:

- 1. Preparing for a measurement
 - Turning ON the analyzer
 - Connecting the test signal source
- 2. Setting up the analyzer
 - Setting the active channel
 - Selecting the analyzer type
 - Selecting the input
 - Setting the frequency range
- 3. Making a Measurement
 - Reading the peak level using the marker
 - Setting the resolution bandwidth to see low level signals
 - Searching for harmonics using the search function
- 4. Saving and recalling the analyzer settings
 - Preparing the disk
 - Saving analyzer settings
 - Entering the file name
 - Recalling the analyzer settings

After you finish this tour, you will understand how to make a basic measurement in the spectrum analyzer mode of operation. If you want to learn how to perform more complex tasks, see the Task Reference manual.

Required Equipment

To perform all the steps in this tour, you must have the following equipment:

- HP 4396A Network/Spectrum Analyzer
- N to BNC Adapter $(50 \Omega)^*$
- BNC cable*
- 3.5 inch 2HD (or 2DD) Blank Disk
- * Furnished with the analyzer.

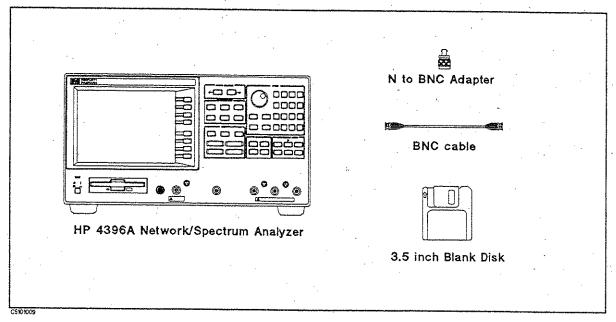
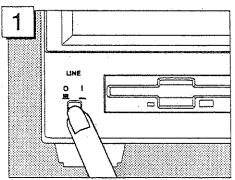


Figure 1-1. Required Equipment

Step 1: Preparing for a Measurement

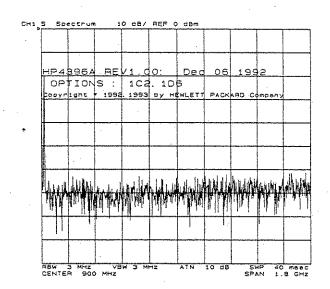
Turning ON the analyzer

Verify the power line setting is correct before you turning ON the analyzer. If necessary, see appendix A, "Installation and Setup Guide."



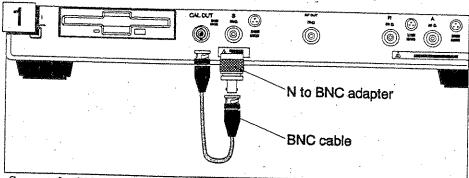
Press the LINE switch

The power on self-test takes about 10 seconds. If the analyzer is operating correctly, the following information is displayed on the CRT:



Connecting the Test Signal Source

In this tour, you use the front-panel CAL OUT signal as the test signal (20 MHz at -20 dBm).



Connect the CAL OUT output to the S input using the N-to-BNC adapter and the BNC cable.

Step 2: Setting Up the Analyzer

In this step, you will set the following parameters:

Active channel

Channel 2

Analyzer type

Spectrum analyzer mode

Input

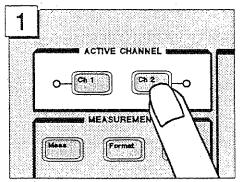
Sinput.

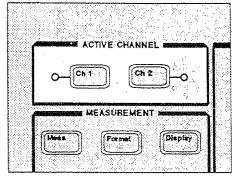
Frequency Range

0 Hz to 80 MHz

Setting the Active Channel

The analyzer has two measurement channels. This allows you to have two different measurement setups. Other selections you make on the front panel affect only the active channel. To set the active channel to channel 2:





In the ACTIVE CHANNEL block, press Ch 2. Verify the Ch 2 active channel indicator lights.

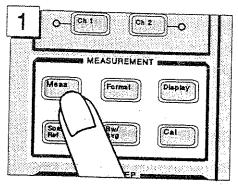
Note



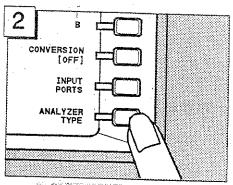
All selected settings are stored separately for each channel. You must select an active channel (1 or 2) before you can change the measurement setup for that channel.

Setting the Analyzer Type

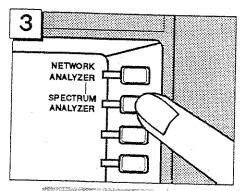
To use the spectrum analyzer mode, you must set the analyzer type to the spectrum analyzer mode after selecting an active channel.



In the MEASUREMENT block, press Meas.



Press ANALYZER TYPE .



Press SPECTRUM ANALYZER.

Note

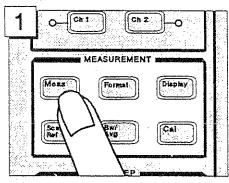


Changing the analyzer type presets the analyzer for the active channel. If you want to keep the current measurement settings when changing the analyzer type, first set the other channel to active.

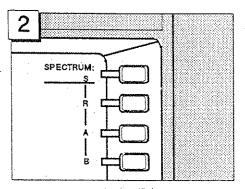
Selecting the Input

The analyzer has four inputs; S, R, A, and B. In most spectrum measurements, the S input is used. The R, A, and B inputs can also be used for a spectrum measurement, but the dynamic range of these inputs is 20 dB worse than the S input and the attenuator is not variable. Therefore, to get the most accurate results, you should use the S input for spectrum measurements.

In the spectrum analyzer mode, the S input is selected by default. In the following steps, you verify the S input is selected.



In the MEASUREMENT block, press (Meas)

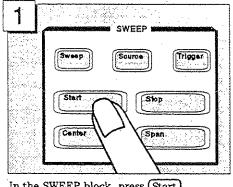


Verify the S in SPECTRUM: S is underlined. (This shows that the S input is selected for a spectrum analyzer measurement.)

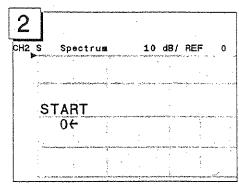
Setting the Frequency Range

The CAL OUT signal (20 MHz at -20 dBm) is connected as test signal source. To see this signal on display, you must set the appropriate frequency range (in this case, 0 to 80 MHz):

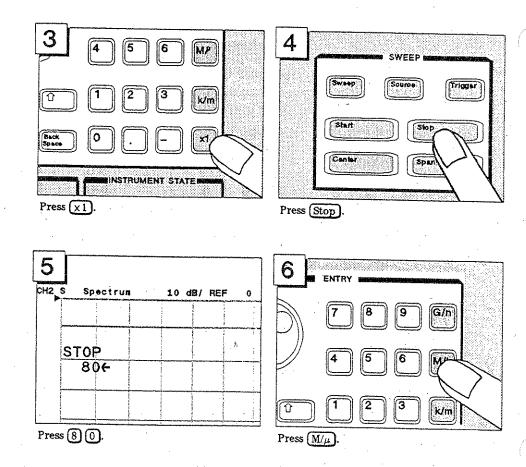
Press (0).



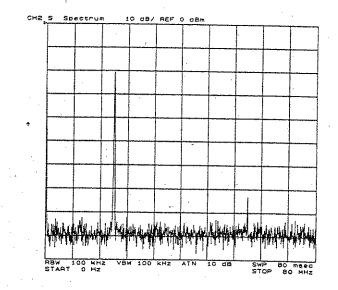
In the SWEEP block, press (Start).



Spectrum Analyzer Tour 1.7



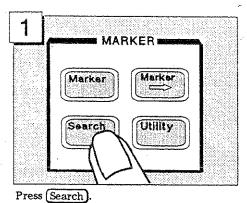
Verify the 20 MHz signal is displayed as shown below:

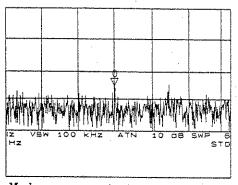


Step 3: Making a Measurement

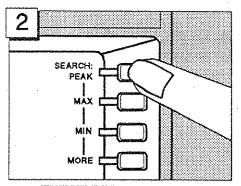
Reading the Peak Level Using the Marker

Let's try to read peak signal level by using the marker:

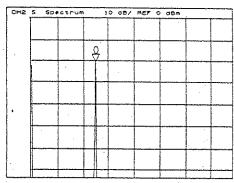




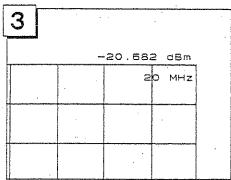
Marker appears on trace.



Press SEARCH: PEAK



Marker moves to the top of the CAL OUT signal.

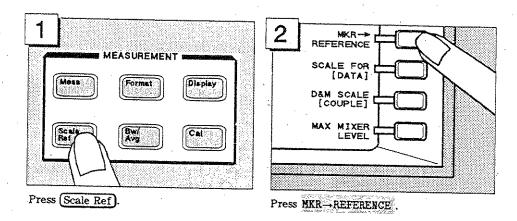


Read the marker value shown at the upper right of grid.

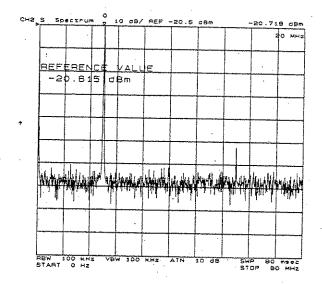
Setting the Resolution Bandwidth to See Low Level Signals

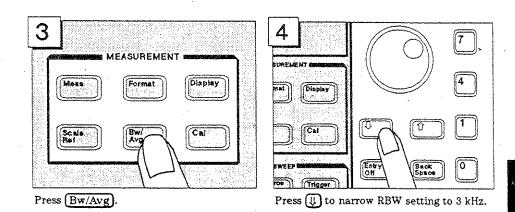
To see lower level signals that are approximately the same level as the noise floor level, use a narrow resolution bandwidth (RBW) setting.

Before you set the RBW, set the maximum peak level as the reference level. This increases the visibility of the lower level signal. This technique is useful when you are measuring two signals and one is very close to the noise level.

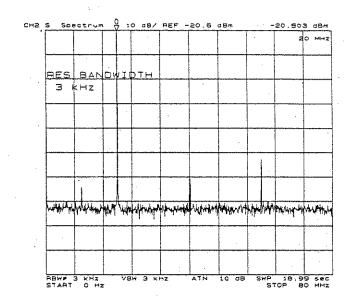


The trace moves upward to place the tip of the maximum peak at the top line of the grid.



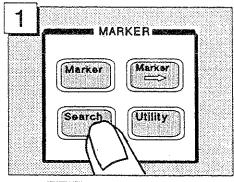


Now, with the noise floor level lowered by narrowing the resolution bandwidth, the second and third harmonics can be seen as shown below:

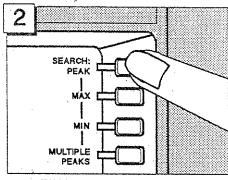


Searching for Harmonics Using the Search Function

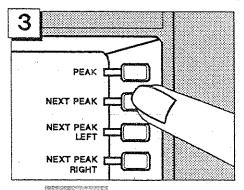
You can easily readout a harmonics' frequency and level by using the peak search function:



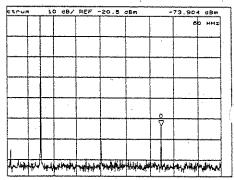
Press (Search)



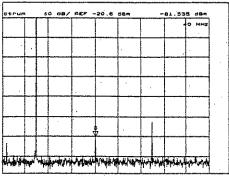
Press SEARCH: PEAK



Press NEXT PEAK



The marker moves to the third harmonic.



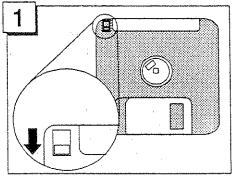
To move the marker to the second harmonic, press NEXT PEAK again.

Step 4: Saving and Recalling Analyzer Settings

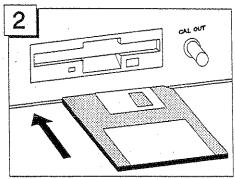
You can store the settings or measurement data on a 3.5 inch disk using the analyzer's disk drive. In this tour, you save and recall the settings that you selected previously in this tour.

Preparing the Disk

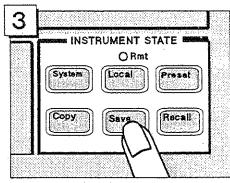
To use a disk, you must first initialize it by performing the following steps:



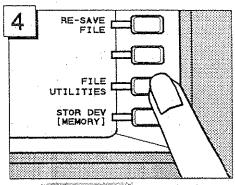
Verify the disk is not write protected.



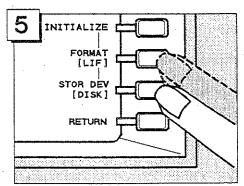
Insert the disk into the disk drive



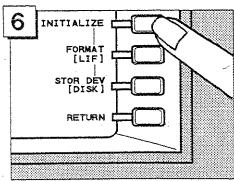
Press Save).



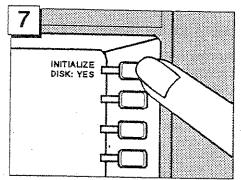
Press FILE UTILITIES .



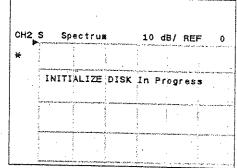
Toggle FORMAT [DOS] to [LIF] and STOR DEV [MEMORY] to [DISK]



Press INTIALIZE DISK.







The message, "INITIALIZE DISK In Progress," is displayed. After the disk is initialized, this message is turned off.

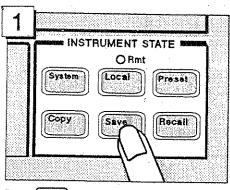
Note



The analyzer can use either a LIF (Logical Interchange Format) or a DOS (Disk Operating System) format disk.

Saving Analyzer Settings

In the following example, use "SATOUR" as the file name of the analyzer settings you want to save.



STATE

DATA ONLY (binary)

DEFINE SAVE DATA ASCII SAVE

Press (Save) Press STATE.

The analyzer requests the file name you want to use for the saved settings.

Entering the File Name

Note



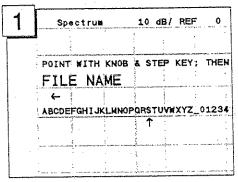
If a keyboard is connected, you can use it for file name entry. If not, use the front-panel controls as described in the following steps.

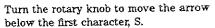
Note

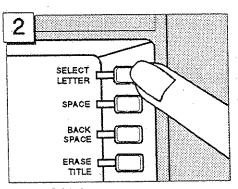


The file name for a LIF format can be up to 10 characters long. However, with the analyzer, the last 2 characters are reserved for a suffix. Therefore, you can enter a file name of up to 8 characters. Either upper or lower case is recognized in the LIF format.

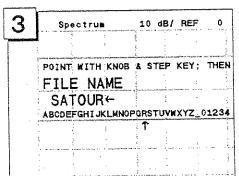
A file name for a DOS format consists of a file name and an extension. The file name can be up to 8 characters long and the extension contains up to 3 characters. A period separates the extension from the file name. The extension part reserved by the analyzer. Therefore, you can enter a file name of up to 8 characters. The file name is not case sensitive in the DOS format.



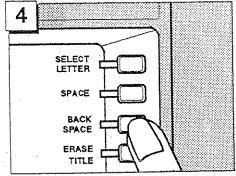




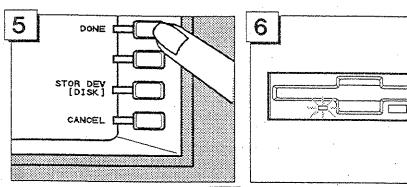
Press SELECT LETTER .



Keep entering characters until SATOUR is entered.



If you enter a wrong character, press BACK SPACE to erase the character.



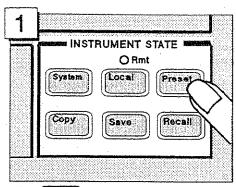
To complete the file name entry, press DONE.

Verify the disk access indicator lights (this shows that the analyzer is saving the settings to the disk).

Recalling the Analyzer Settings

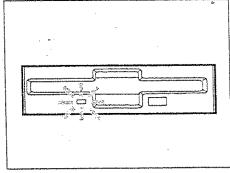
You can recall the file containing the saved analyzer settings anytime you want. This is true, even if you change the current analyzer settings. In this example, you will preset the analyzer and then recall the settings in the SATOUR file.

Presetting



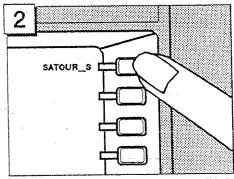
Press (Preset).

The analyzer is set to the preset conditions. However, the analyzer settings from the previous examples are stored in the SATOUR file on the disk.



Press Recall

The disk access lamp lights.



The stored file is listed in the softkey label area. Press SATOUR_S to recall the analyzer settings that you saved.

Note



Suffix, "_S," means the analyzer settings are saved. If you save the analyzer settings in a DOS format, an extension, ".sta," is appended to the file name.

After the disk access lamp goes out, all analyzer settings that you set are recalled. You can verify them on the display. If you want to know what settings are saved, see chapter 8 of the Function Reference manual.

Network Analyzer Tour

In this chapter, you explore the network analyzer mode of operation. Before starting this tour, verify the analyzer is correctly installed (see appendix A, "Installation and Setup Guide," if you need additional information).

Before You Leave On The Tour

On this tour, you will learn how to make a basic network analyzer measurement by measuring the transmission characteristics of a bandpass filter.

Overview

The following is a short summary of the tour:

- 1. Preparing for a measurement
 - Turning ON the analyzer
 - Connecting the DUT
- 2. Setting up the analyzer
 - Setting the active channel
 - Selecting the analyzer type
 - Setting the input port
 - Setting the frequency range
 - Performing the automatic scaling
- 3. Making a calibration
- 4. Reading a measurement result
 - Reading a measured value by using marker
- 5. Printing out the measurement result
 - Configuring and connecting a printer
 - Making a hardcopy of the display

After you finish this tour, you will understand how to make a basic measurement in the network analyzer of operation. If you want to learn how to perform more complex tasks, see the Task Reference manual.

Required Equipment

To perform all the steps in this tour, you must have the following equipment:

- HP 4396A Network/Spectrum Analyzer
- Measurement Device:
 - □ This tour assumes the device under test (DUT) is a 70 MHz bandpass filter
- THRU (BNC female-to-female connector)
- Two BNC cables
- Test Set (use either of the following)
 - □ Transmission/Reflection (T/R) Test Set
 - Two N-to-BNC adapters
 - ☐ S-Parameter Test Set
 - Two APC7-to-N adapters
 - Two N-to-BNC adapters
- HP-IB Printer *
- HP-IB Cable
- * If you do not have an HP-IB printer and cable, skip step 5, "Printing Out the Measurement Results".

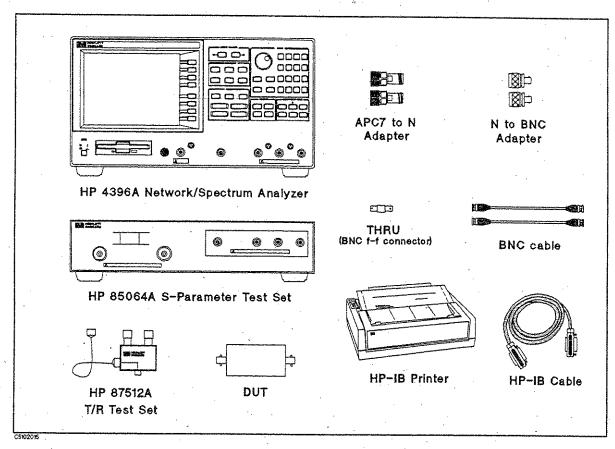
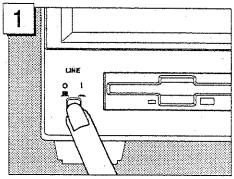


Figure 2-1. Required Equipment

Step 1: Preparing for the Measurement

You must set up the test set before you turn ON the analyzer. The setup procedure for the test set is described in "Connecting a Test Set for Network Analyzer Mode" in Appendix A.

Turning ON the Analyzer



Press the LINE switch.

The power on self-test takes about 10 seconds.

Connecting the DUT

Connect the DUT as shown in Figure 2-2 or Figure 2-3.

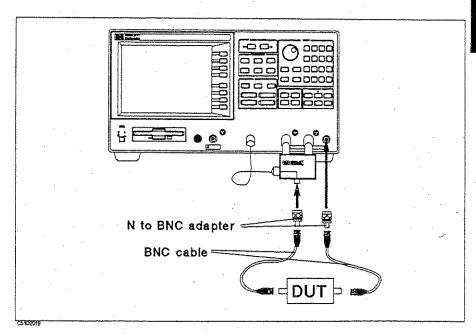


Figure 2-2. Transmission/Reflection Test Set Setup

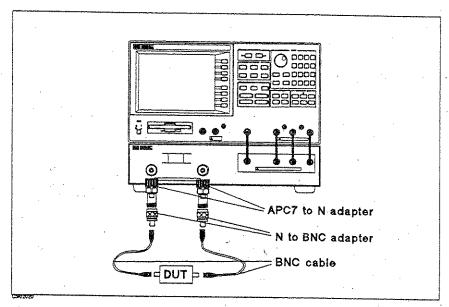


Figure 2-3. S-Parameter Test Set Setup

Step 2: Setting up the Analyzer

Before you start the measurement, you must set up the analyzer to fit your measurement requirements. For example, you must set the frequency range of the measurement. In this step, you will set the following parameters:

Active channel

Channel 1

Analyzer type

Network analyzer mode

Inputs

B/R or S_{21} (depending on the test set)

Format

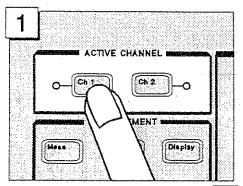
Log magnitude (default)

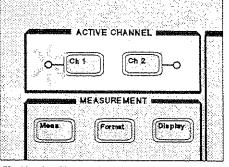
Frequency Range

Center 70 MHz, Span 500 kHz

Setting the Active Channel

Because the analyzer has two measurement channels you can have two different measurement setups at the same time. To change the active channel to channel 1:

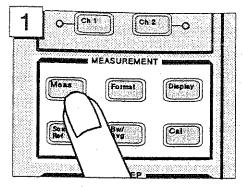




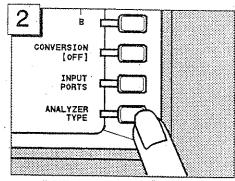
In the ACTIVE CHANNEL block, press Ch 1). Verify the Ch 1 active channel indicator lights.

Setting the Analyzer Type

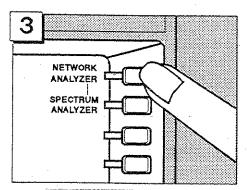
To use the analyzer in the network analyzer mode, you must set the analyzer type to the network analyzer mode after selecting the active channel.



In the MEASUREMENT block, press Meas



Press ANALYZER TYPE



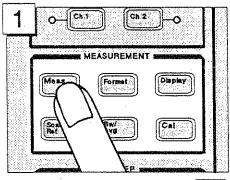
Press NETWORK ANALYZER

Selecting the Input

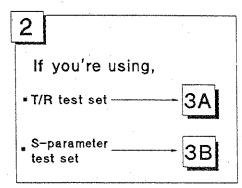
The analyzer uses three inputs for network measurements (R, A, and B). Usually, the R input accepts the RF OUT signal directly, the A input receives the reflection signal from the DUT, and the B input receives the transmission signal through the DUT.

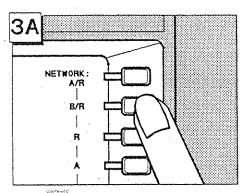
This example assumes you are using the T/R test set. Therefore, because you are going to measure the transmission characteristics of the DUT, select B/R to measure the ratio of B and R inputs.

When you use the S-parameter test set, you can measure the forward and reverse characteristics of a 2-port device without reconnecting the inputs. In that case, select S21 for a transmission measurement in the forward direction.

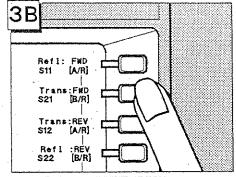


In the MEASUREMENT block, press (Meas)





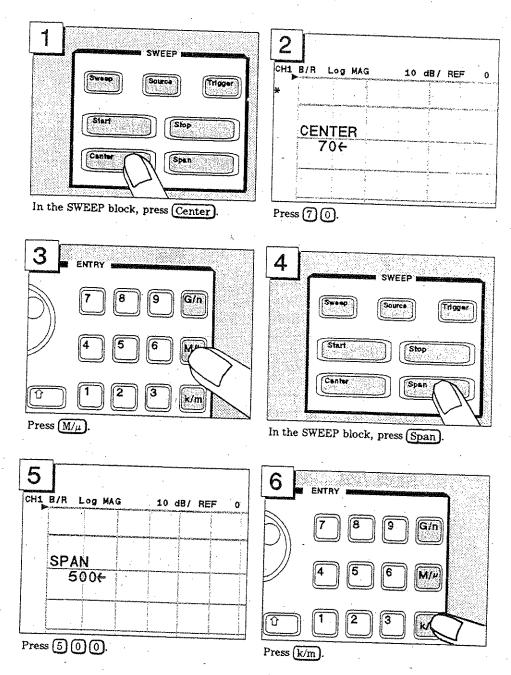
Press B/R.



Press Trans:FWD S21 [B/R] to select B/R for the forward direction.

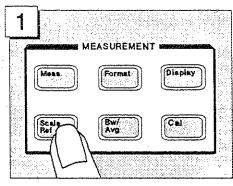
Setting the Frequency Range

To display the transmission characteristics of the 70 MHz bandpass filter, you should specify the frequency range for the measurement. In this example, set the analyzer to a 70 MHz center frequency with a 500 kHz span.



Performing the Automatic Scaling

Often, the trace obtained after specifying the frequency range is too large or too small vertically for the grid. However, by using the automatic scaling function, you can obtain the optimum vertical setting automatically.

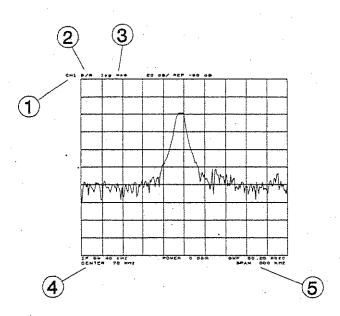


AUTO SCALE SCALE/DIV REFERENCE POSITION REFERENCE

In the MEASUREMENT block, Press (Scale Ref).

Press AUTO SCALE.

The transmission characteristics trace of the filter is displayed as shown below:



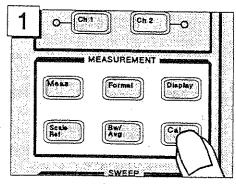
All the settings are displayed on the CRT.

- 1. Active channel is set to channel 1.
- 2. Inputs are set to B/R.
- 3. Format is set to log magnitude mode.
- 4. Center frequency is set to 70 MHz.
- 5. Frequency span is set to 500 kHz.

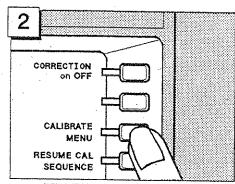
Step 3: Making a Calibration

To ensure accurate measurement results, calibrate the analyzer before making a measurement. Calibration reduces error factor due to uncertainty. In this example, you perform the response calibration to cancel a frequency response error. A THRU (BNC female-to-female connector) is necessary to perform a response calibration for the transmission measurement.

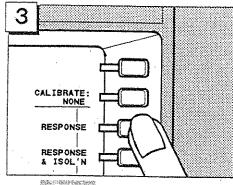
Performing a Response Calibration (for the Transmission Measurement)



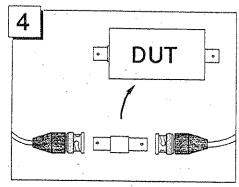
Press Cal.



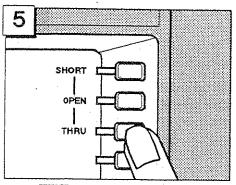
Press CALIBRATE MENU.



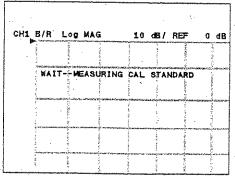
Press RESPONSE



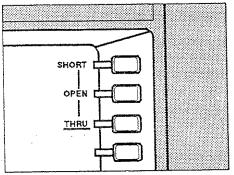
Disconnect the DUT then, connect the THRU.

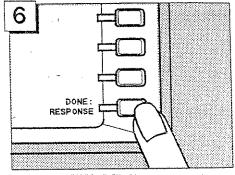


Press THRU .



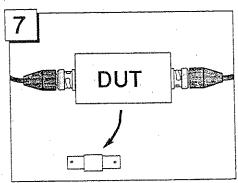
WAIT - MEASURING CAL STANDARD is displayed.





The THRU softkey label is underlined when the measurement is completed.

Press DONE: RESPONSE.



Disconnect the THRU and reconnect the DUT.

"Cor" is displayed on the left side of the display to show that the frequency response error is corrected.

The measured value is now corrected for the frequency response error.

Note

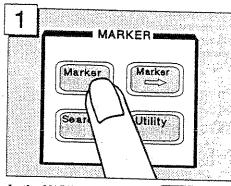


If the trace is changed, it requires an adjustment of the scale. Perform the automatic scaling again by pressing Scale Ref AUTO SCALE.

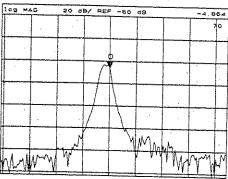
Step 4: Reading a Measurement Result

You may want to readout the measured values on the displayed trace. You can use the marker function for this purpose. The marker shows the frequency and response value at the marker point.

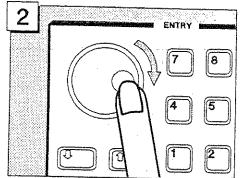
Reading a Measured Value by Using Marker



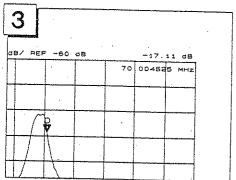
In the MARKER block, press Marker).



Verify a marker appears on the trace.

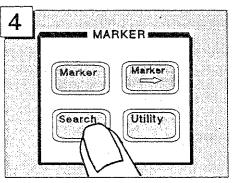


Turn the knob to the right to move the marker toward the right.

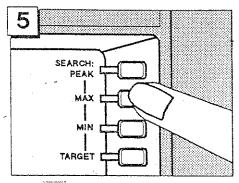


Read the values at the right top of the display.

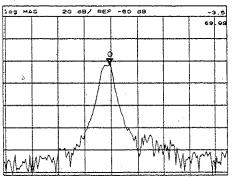
The marker has a search function that makes it easier and faster to evaluate the trace results. For example, to search for the maximum value and its frequency on the trace:



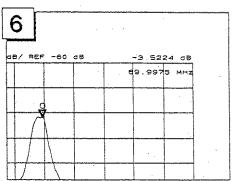
In the MARKER block, press Search.



Press MAX.



The marker immediately moves to the maximum point on the displayed trace.

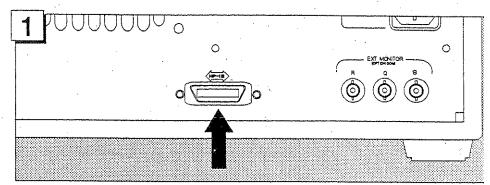


Read the frequency and response values displayed at the upper right of the display.

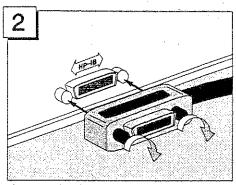
Step 5: Printing Out the Measurement Result

You may want a hardcopy of the measured results for a permanent record of the measurement. The analyzer can print out the data as a snapshot of the display or as a list of values without using any external controller.

Configuring and Connecting a Printer



Locate the HP-IB connector on the back of the analyzer.



Connect the HP-IB cable to the analyzer HP-IB connector.

- 3 Connect the other end of the HP-IB cable to the printer.
- Set the HP-IB address of the printer to 1.*

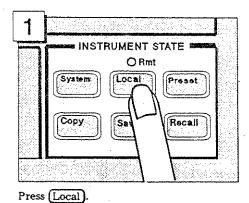
Note

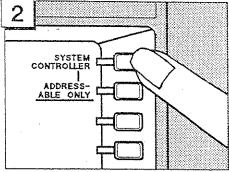


You must specify a unique HP-IB address. The HP-IB address is used to identify an instrument on the HP-IB line. The printing operation does not work if you specify an address that is the same address as another instrument on the HP-IB. In this example, you set the HP-IB address of the printer to 1. This is the default value used for a printer in the analyzer.

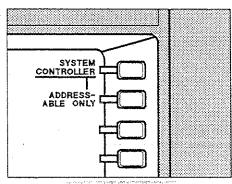
^{*} See the printer operating manual for detailed information.

Making a Hardcopy of the CRT Display

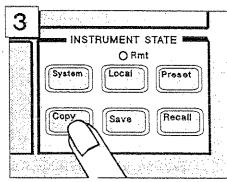




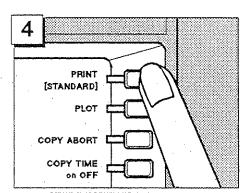
Press SYSTEM CONTROLLER.



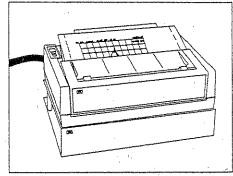
Verify the SYSTEM CONTROLLER label is underlined.



Press Copy



Press PRINT [STANDARD] to execute the printing.



The printer prints out the display image.

Spectrum Measurement Examples

This chapter contains the following spectrum measurement examples:

- Harmonic distortion measurement
- Carrier/noise ratio (c/N) measurement
- Tracking a drifting signal
- Network measurement with spectrum monitor
- Amplitude modulation (AM) signal measurement
- Frequency modulation (FM) signal measurement
- Burst signal measurement

Basic Setup

To measure the spectrum of a test signal, use the S input as shown in Figure 3-1.

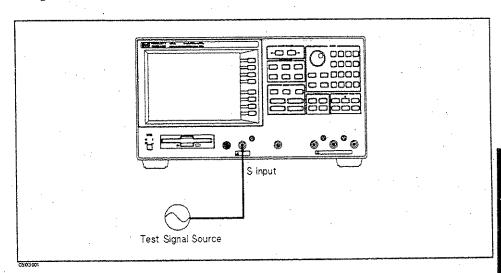


Figure 3-1. Basic Connection for Spectrum Measurement

The spectrum of input signals can also be monitored at the A, B, and R inputs. The use of the spectrum monitor function is described later in this chapter.

Harmonic Distortion Measurement

The analyzer can simultaneously display the difference values between the fundamental and harmonics up to the seventh harmonic. The test signal used in this example is the output of an amplifier with a 20 MHz sine wave input signal.

Test Signal and Test Device

The following test signal and device are used in this example.

- Input Test Signal
 - □ Frequency: 100 MHz
- Test Device

 □ Amplifier

Measurement Setup

Connection

Set up the analyzer as shown in Figure 3-2.

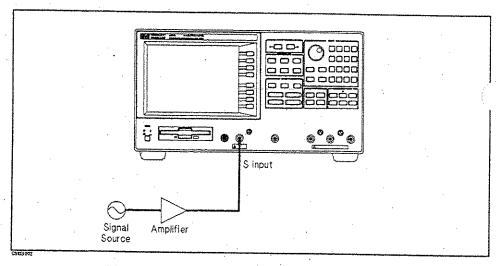


Figure 3-2. Harmonics Measurement Setup

Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	(Ch 1) (default)
Measurement Block	Select Spectrum Analyzer	Press Meas ANALYZER TYPE SPECTRUM ANALYZER
	Select S input	Meas SPECTRUM: S (default)
Sweep Block	Start frequency 50 MHz	Press Start 50 (M/ μ)
	Stop frequency 1.8 GHz	Press (Stop) 1.8 (G/n)

Multiple Peak Search and Marker List For Harmonic Distortion Measurement

Harmonic components can be read (to 5 digits resolution) by moving the marker to each harmonic. The marker and seven sub-markers can be moved to peaks automatically. Amplitude and frequency of all markers on the trace are read at the same time. The following procedure displays the value of the fundamental and the harmonics:

- 1. Press Marker AMODE MENU TRACKING AMKR to turn the tracking Δmarker on. The tracking Δmarker always tracks the marker.
- 2. Press (Search) SEARCH TRK on OFF to ON off to turn the search tracking on.
- 3. Press Search MULTIPLE PEAKS SEARCH: PEAKS ALL to move the marker to the fundamental and turn on and move the sub-markers to individual harmonics.
- 4. Press Utility MKR LIST on OFF to ON off to turn marker list on. The Amarker and all sub-marker values are displayed as shown in Figure 3-3.

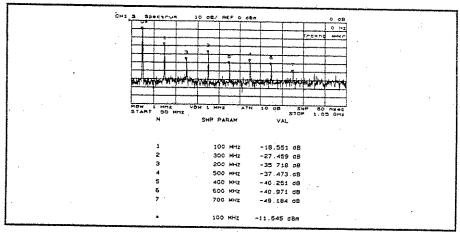


Figure 3-3. Using Multiple Peak Search and Marker List to Measure Harmonic Distortion

5. Press Marker PRESET MKRS, when you are finished with this measurement.

C/N Measurement

C/N is the ratio of the carrier to the noise. The analyzer can measure noise level directly and read out the C/N using the marker functions.

Do the "Harmonic Distortion Measurement" before doing this measurement.

Test Signal

This example uses the same test signal used in the "Harmonic Distortion Measurement" example.

Measurement Setup

Connection

This example assumes that the connections and instrument settings made in the "Harmonic Distortion Measurement" example are still in effect.

Analyzer Settings

Change the following settings for this measurement:

■ Press Center $100 \, (\text{M}/\mu)$ and $(\text{Span}) \, 100 \, (\text{k/m})$ to zoom to the fundamental on the display.

Fixed AMarker and Noise Format for C/N Measurement

- 1. Press Search MAX to search for the carrier.
- 2. Press (Scale Ref) MKR \rightarrow REFERENCE.
- 3. Press Marker AMODE MENU AMKR 10 k/m to put Amarker on the carrier and to move the marker to the 10 kHz offset point.
- 4. Press (Bw/Avg) VIDEO BW 10 (x1).
- 5. Press (Utility) NOISE FORM on OFF to ON off. The analyzer displays the C/N ratio with the unit of "dB/Hz" at the upper right of the display as shown in Figure 3-4.

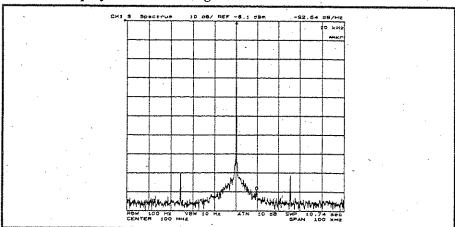


Figure 3-4. Using Markers and Noise Format to Measure C/N Ratio

6. Press (Marker) PRESET MKRS when you are finished with this measurement.

Tracking a Drifting Signal

When measuring a drifting signal, the analyzer can lose the signal. However, the analyzer can track a drifting signal by changing the sweep parameter values sweep by sweep.

Test Signal

The following test signal is used in this example.

■ Frequency: 900 MHz (not stable)

Measurement Setup

Connection

Connect the test signal to the S input.

Analyzer Settings

1. Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement Block	Select Spectrum Analyzer	Press Meas ANALYZER TYPE SPECTRUM ANALYZER
	Select S input	Meas SPECTRUM: S (default)
Sweep Block	Center frequency 900 MHz	Press Center 900 M/µ
	Span frequency 20 kHz	Press Span 20 k/m

2. Set channel 2 the same as channel 1 as follows:

-	Desired Settings	Key Strokes
Active Channel Block	Select channel 2	Ch 2
Measurement Block	Select Spectrum Analyzer	Press Meas ANALYZER TYPE SPECTRUM ANALYZER
	Select S input	Meas SPECTRUM:S (default)
Sweep Block	Center frequency 900 MHz	Press Center 900 M/µ
•	Span frequency 20 kHz	Press Span 20 k/m

Tracking an Unstable Signal

In this example, the signal is drifting.

- 1. Press Display DUAL CHAN on OFF to ON off
- 2. Press Ch 1).
- 3. Press Marker to turn the marker on.
- 4. Use the knob to bring the marker close to the signal you want to track.
- 5. Press Search SIGNAL TRK on OFF to turn the signal track on. As the signal drifts, the center frequency automatically changes to bring the signal and the marker to the center of the display.

Figure 3-5 shows a display when signal track is ON at channel 1. Figure 3-6 shows a display after the analyzer sweeps a few times. At channel 1, the center frequency has been changed to maintain the drifting signal at the center of the display. Channel 2 shows that signal frequency has drifted to a higher frequency.

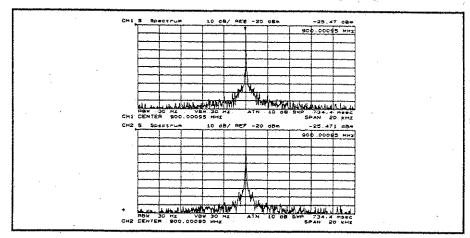


Figure 3-5. Display When Starting Signal Track

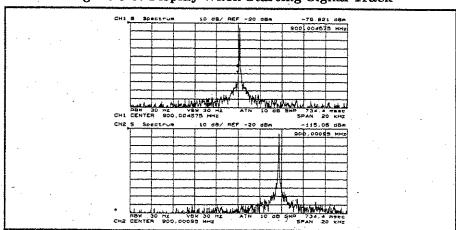


Figure 3-6. Display After Signal Has Drifted

Network Measurement with Spectrum Monitor

During a network measurement, crosstalk or leakage (such as noise) from an adjacent circuit can change the measurement results. To detect the effect of these spurious inputs, the analyzer can monitor the spectrum of the input signal at the R, A, and B inputs.

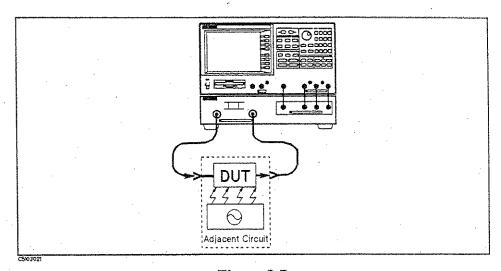


Figure 3-7. Influence on Network Measurement by Leakage from an Adjacent Circuit

Measurement Setup

In this example, the network measurement circuit has leakage from an adjacent signal source. The frequency of the signal source is 240 MHz and the DUT is a 250 MHz bandpass filter.

Connection

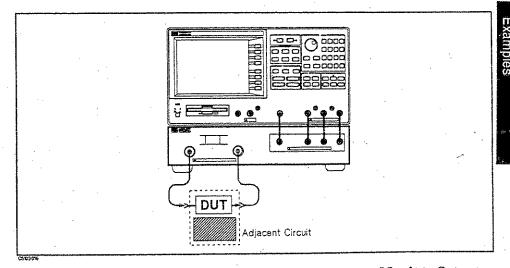


Figure 3-8. Network Measurement With Spectrum Monitor Setup

Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement	Select Spectrum Analyzer	Press Meas ANALYZER TYPE NETWORK ANALYZER
Block	Select S ₂₁ (or B/R) measurement	Meas Trans: FWD S21 [B/R]
	Select LOG MAG format	Format LOG MAG (default)
Sweep Block	Center frequency 250 MHz	Press (Center) 250 (M/ μ)
	Span frequency 200 MHz	Press (Span) 200 (M/µ)

Performing Calibration

Perform a frequency response calibration for this measurement as follows:

- 1. Press Cal CALIBRATE MENU RESPONSE.
- 2. Connect a THRU calibration standard between the measurement cables in place of the DUT.
- 3. Press THRU to perform a frequency response calibration data measurement.
- 4. Press DONE: RESPONSE. (CORRECTION on OFF is automatically set to CORRECTION ON off.)

Network Measurement

- 1. Press Scale Ref AUTO SCALE to fit scale to the trace.
- 2. Press Search PEAK to put the marker on an unknown peak of the trace. The transmission measurement result is displayed as shown in Figure 3-9.

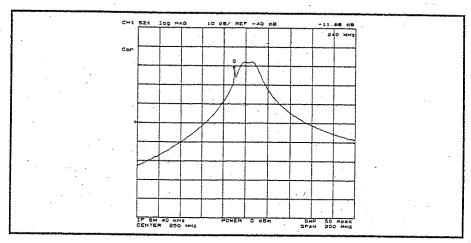
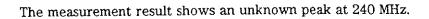


Figure 3-9.
Transmission Measurement Result (Influenced by Leakage)



Monitoring the Leakage Signal at the B Input Using the Spectrum Monitor

During the spectrum measurement sweep, the network measurement is turned off. To monitor the input signal at the B input:

- 1. Press Ch 2.
- 2. Press (Meas) ANALYZER TYPE SPECTRUM ANALYZER B.
- 3. Press (Center) 250 (M/ μ).
- 4. Press (Span) 200 (M/ μ).

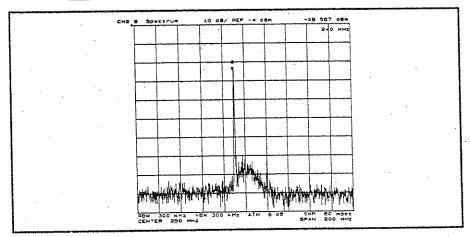


Figure 3-10. Spectrum Monitoring Result at the B Input

The spectrum measurement result shows the leakage signal at $240\,$ MHz.

5. Press Display DUAL CHAN on OFF to ON off to perform and display both the network and the spectrum measurements at the same time.

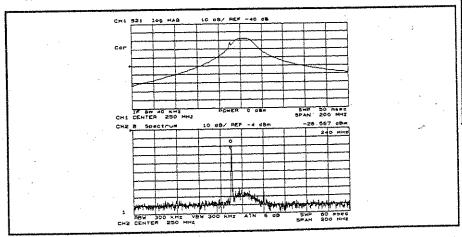


Figure 3-11. Dual Display of Network and Spectrum Measurement

AM Signal Measurement

In this example, the following parameters for AM signal measurement are derived:

a Carrier amplitude (E_c) and frequency (f_c)

Modulating frequency (f_m) and modulation index (m)

Test Signal

The following test signal is used in this example:

AM Signal

 \Box Frequency (f_c): 100 MHz

 \square Modulating signal frequency (f_m) : 10 kHz

 \square Modulation index (m): 15%

Measurement Setup

Connection

Connect the test signal source to the S input.

Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement Block	Select Spectrum Analyzer	Press (Meas) ANALYZER TYPE SPECTRUM ANALYZER
DIOCA	Select S input	Meas SPECTRUM: S (default)
Sweep Block	Center frequency 100 MHz	Press Center 100 (M/µ)
· · · · · · · · · · · · · · · · · · ·	Span frequency 200 kHz	Press (Span) 200 (k/m)

Carrier Amplitude and Frequency Measurement Using the Marker

Press Scale Ref and enter the reference value if the trace needs to be rescaled.

- 1. Press (Search) to turn the marker on.
- 2. Press MAX to search for the carrier signal. The carrier amplitude and frequency are displayed in the upper right corner as shown in Figure 3-12.

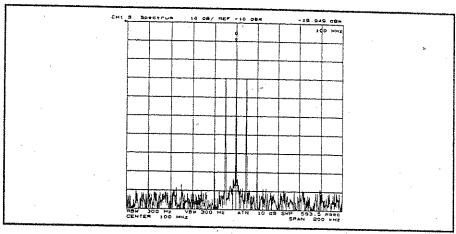


Figure 3-12. Carrier Amplitude and Frequency of AM Signal

The marker shows that the carrier amplitude (E_c) is -19.949 dBm and frequency (f_c) is 100 MHz.

Modulating Frequency and Modulation Index Measurement Using AMarker

- 3. Press Marker AMODE MENU AMKR.
- 4. Press (Search SEARCH: PEAK NEXT PEAK to search for a sideband. The offset value from the carrier is displayed as the marker sweep parameter value shown in Figure 3-13. This value is the modulation frequency.

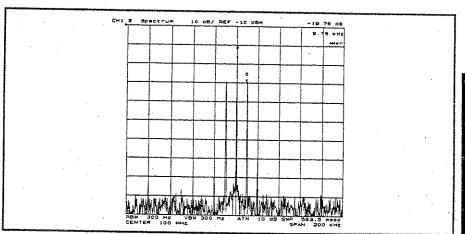


Figure 3-13. Modulating Frequency of AM Signal

The Amarker shows that the sideband amplitude value relative to the carrier is -19.76 dB. The modulation index (m) can be derived from the following equation:

$$m = 2 \times 10^{-\frac{\Delta M/cr}{20}}$$
$$= 19.45\%$$

where ΔMkr is the Δ marker sweep parameter value shown in Figure 3-13.

FM Signal Measurement

This example describes how to derive the frequency deviation (Δf_{peak})

Test Signal

The following test signals are used in this example:

- Wide band FM Signal
 - □ Carrier frequency: 100 MHz.
 - □ Modulating frequency: 1 kHz.
 - □ Frequency deviation: 1 MHz.
- Narrow band FM Signal
 - □ Carrier frequency: 100 MHz.
 - □ Modulating frequency: 1 kHz.
 - □ Frequency deviation: 5 kHz.

Measurement Setup

Connection

Connect the test signal to the S input.

Analyzer Settings

Press Preset. Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel I	Ch 1 (default)
Measurement Block	Select Spectrum Analyzer Select S input	Press (Meas) ANALYZER TYPE SPECTRUM ANALYZER (Meas) SPECTRUM: S (default)
	RBW 1 kHz	(Rw/Avg) 1 (k/m)
Sweep Block	Center frequency 100 MHz	Press Center 100 (M/µ)
	Span frequency 5 MHz	Press Span 5 M/µ

Frequency Deviation of Wide Band FM Signal

Press (Scale Ref) and enter reference value if the trace needs to be rescaled.

Frequency Deviation

- 1. Press (Search) SEARCH: PEAK
- 2. Press (Marker) AMODE MENU AMKR.
- 3. Press (Search) SEARCH: PEAK NEXT PEAK.

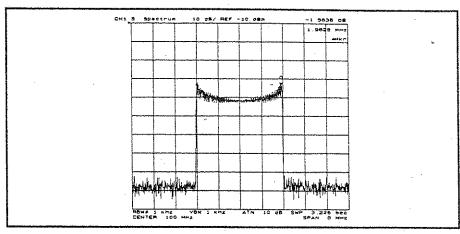


Figure 3-14. Wide Band FM Signal Measurement

The frequency deviation (Δf_{peak}) can be derived from the following equation:

$$\Delta f_{peak} = \frac{|\Delta Mkr|}{2}$$

where ΔMkr is the marker sweep parameter value shown in Figure 3-14. In this example, the frequency deviation is about 981 kHz.

Press (Marker) PRESET MKRS when you are finished with this measurement.

Carrier Level and Modulating Frequency

The carrier level and modulating frequency can be derived using a method similar to the AM signal measurement. In this example, the zooming function is used to measure the carrier and the adjacent signal.

- 4. Press (Display) DUAL CHAN on OFF to ON off.
- 5. Press (Marker) to put the maker on the carrier frequency.
- 6. Press $(Marker \rightarrow)$ MORE ZOOMING APERTURE 0.2×1 .
- $^{7}\cdot$ Press CROSS CHAN on OFF to ON off.
- 8. Press RETURN MKR ZDOM to zoom up to the carrier signal.
- 9. Press (Ch 2).
- 10. Press (Scale Ref) and enter reference vale if the trace needs to be rescaled.
- 11. Press (Marker) 100 (M/ μ) to move the marker to the career frequency. The carrier amplitude can be read as the marker value.
- 12. Press Marker ΔMODE MENU ΔMKR to put the Δmaker on the carrier.
- 13. Press (Search) SEARCH: PEAK LEFT PEAK (or RIGHT PEAK) to move the marker to the sideband.

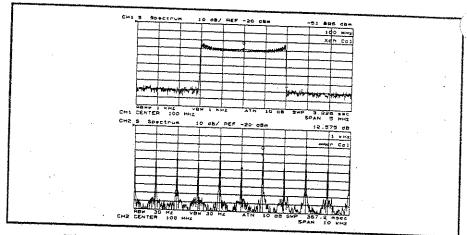


Figure 3-15. Zooming Carrier Signal of FM Signal

Press Display DUAL CHAN ON off to on OFF and then Ch 1 when you are finished with this measurement.

Narrow Band FM Signal Measurement

- 1. Change the test signal source to the narrow band FM signal.
- 2. Press Ch 1 Span 100 k/m Bw/Avg 10 k/m. The spectrum of the narrow band FM signal is displayed.
- 3. Press Scale Ref -10×1 .

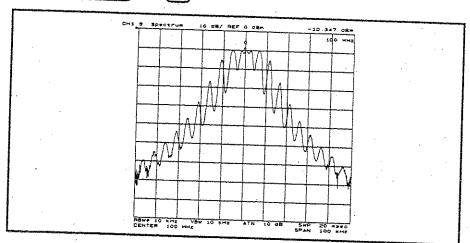


Figure 3-16. Narrow Band FM Signal Measurement

- 4. Press Ch 2 Span 100 k/m Bw/Avg 10 k/m Scale Ref -10 $\times 1$ as same as channel 1.
- 5. Press Display DATA HOLD [OFF] MAX and then wait for a few sweeps until the trace is stable. The maximum envelope is displayed.
- 6. Press Display DATA—MEMORY DATA and MEMORY to store and display the maximum envelope.

- 7. Press DATA HOLD [MAX] MIN and then wait for a few sweeps until the trace is stable. The minimum envelope is displayed.
- 8. Press Marker MKR ON [DATA] to [MEMORY]. Then turn the knob to move the marker to the desired position to measure the frequency deviation.
- 9. Press AMODE MENU FIXED AMKR.
- 10. Press RETURN MKR ON [MEMORY] to [DATA] . Then turn the knob to move the marker to the position that is the same value as the fixed Amarker value.

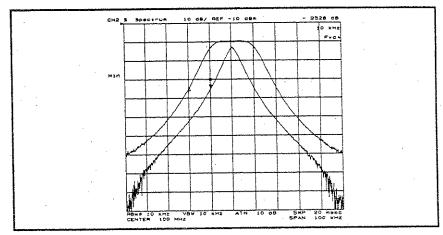


Figure 3-17. Maximum and Minimum Envelopes of Narrow Band FM Signal

The frequency deviation (Δf_{peak}) can be derived from the same equation that is used for the wide band FM signal. In this example, Δf_{peak} can be derived to be 5 kHz.

- 11. Press Display DUAL CHAN on OFF to ON off. Both the spectrum and its envelope are displayed on the split display.
- 12. Press MORE SPLIT DISP ON off to on OFF. The analyzer superimposes the spectrum on the envelopes as shown in Figure 3-18.

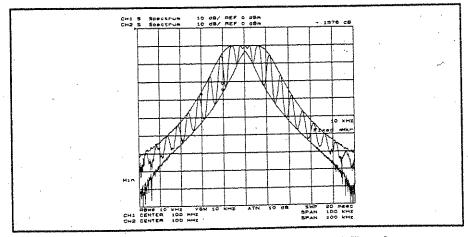


Figure 3-18. Superimposing Spectrum and Envelopes

Burst Signal Measurement

This measurement requires that option 1D6 be installed in the analyzer. A summary of how to determine gate delay and gate length settings for different signals is contained at the end of this example.

Test Signal

The following test signal is used in this example:

- Pulse period (PRI) = $100 \mu s$ (pulse repetition frequency PRF is $10 \mu s$
- \blacksquare Duty ratio is 80% (pulse width au is 80 μ s)
- RF frequency is 960 MHz

Measurement Setup

Connection

Setup the analyzer as shown in Figure 3-19.

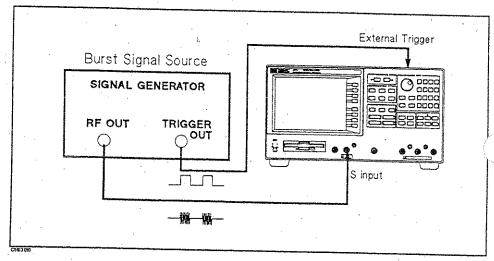


Figure 3-19. Burst Signal Measurement Setup

Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1) (default)
Measurement Block	Select Spectrum Analyzer	Press Meas ANALYZER TYPE SPECTRUM ANALYZER
	Select S input	Meas SPECTRUM: S (default)
	Set RBW to 100 kHz	Press Bw/Avg 100 (k/m)
Sweep Block	Center frequency 960 MHz	Press Center) 960 (M/µ)
-	Span frequency 10 MHz	Press (Span) 10 (M/µ)

Gated Sweep for Burst Signal Measurement

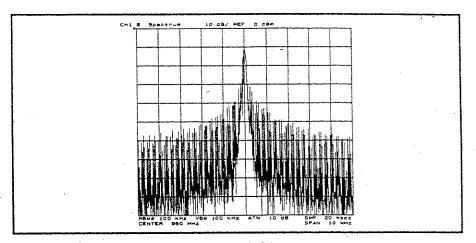


Figure 3-20. Burst Signal Measurement Result Using Normal Sweep

- 1. Press (Trigger) TRIGGER: [FREE RUN] GATE [LEVEL] EDGE to select the trigger mode to the edge mode.
- 2. Press GATE DELAY 30 M/μ for setup time of the RBW.
- 3. Press GATE LENGTH 30 M/μ . The analyzer displays only the RF signal spectrum as shown in Figure 3-21.

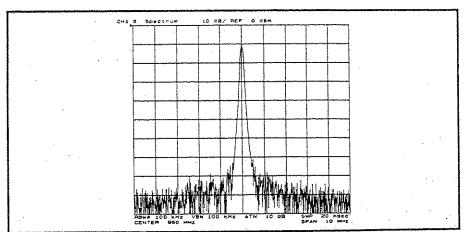


Figure 3-21. Burst Signal Measurement Using Gated Sweep

Zero Span for Time Domain Measurement

Using zero span, the analyzer can show the envelope of the burst signal. The repetitive sampling mode can sample a faster signal.

- 1. Press (Trigger) SWEEP: HOLD to keep the channel 1 trace.
- 2. Press (Display) DUAL CHAN on OFF to ON off.
- 3. Press (Ch 2).

- 4. Press (Meas) ANALYZER TYPE SPECTRUM ANALYZER.
- 5. Press (SPAN) ZERO SPAN
- 6. Press TRIGGER: [GATE] EXTERNAL.
- 7. Press (SWEEP) SAMPLING NORM rept to norm REPT to change the sampling mode to the repetitive sampling mode.
- 8. Press NUMBER of POINTS 101 \times 1. Then press SWEEP TIME 550 (M/μ) .

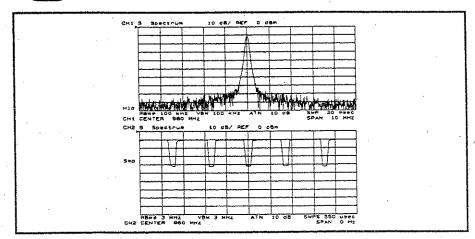


Figure 3-22. Burst Signal Spectrum and Test Signal Envelope

PRI Pulse Width(T) RF: Trigger Delay (Tol. | Gate | Langth(Tg) RBW Setup Time:

How to Determine Gate Delay and Gate Length

Gate Delay

Because the RBW filter requires setup time for the filter to stabilize after triggering, the gate delay must meet the following limit:

$$T_d > \frac{2}{RBW}$$

In this example, RBW = 100 kHz,

$$T_d > \frac{2}{100 \times 10^3} = 20 \mu$$

therefore, the delay time T_d in this example must meet the following condition:

$$T_d > 20 \mu$$

Gate Length

Because the summation of gate delay T_d and the gate length T_g must be less than the pulse length (τ) , the gate length must meet the following limit:

$$T_d + T_g < \tau$$

In this example, $\tau = 80\mu$,

$$T_q < 80\mu - T_d$$

If T_d is set to 30 μ in this example, T_g must meet the following limit:

$$T_g < 50\mu$$

For more information on the gated sweep and the repetitive sampling mode, see the *Function Reference* manual.

This chapter contains the following network measurement examples:

- **■** Transmission Measurement
 - □ 3 dB bandwidth
 - □ Ripple or flatness
 - □ Magnitude and phase characteristics
 - Expanded phase characteristics
- Electrical length measurement
- Phase distortion measurement
 - □ Deviation from linear phase
 - □ Group delay
- Reflection measurement
 - □ Return loss
 - □ Reflection coefficient
 - ☐ Standing wave ration (swr.)
- S-parameters measurement
- Impedance and admittance measurement
- List sweep
 - □ Sweep time reduction
 - ☐ Dynamic range enhancement
- Filter testing using limit line
- Gain compression measurement

Basic Setup

All the examples described in this chapter use the HP 85046A/B S-parameter Test Set to connect to the device under test (DUT). This approach simplifies the measurement setup.

Example DUT

The DUT used in the examples in this chapter is a dielectric bandpass filter with a 836 MHz center frequency. If you use your own DUT, modify the parameter values (measurement frequency range, signal level, etc.) as appropriate for your DUT.

Measuring Transmission Characteristics of a Filter

Insertion loss and gain are ratios of the output to input signals. The following procedure measures the insertion loss and gain of a 836 MHz dielectric bandpass filter. This measurement can be used to obtain the key filter parameters.

Measurement Setup

Connection

Set up the analyzer as shown in Figure 4-1.

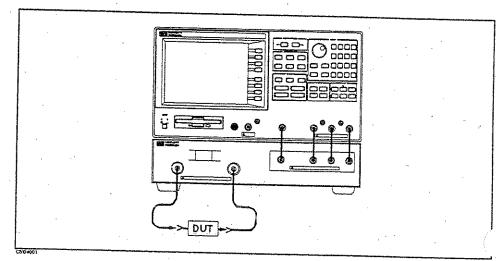


Figure 4-1. Transmission Measurement Setup Analyzer Settings

Press Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement block	Select Network Analyzer	Press Meas ANALYZER TYPE NETWORK ANALYZER
	Select S ₂₁ (or B/R) measurement	Press Meas Trans:FWD S21 [B/R]
	Select LOG MAG format	Format LOG MAG (default)
	IF BW 3 kHz	Bw/Avg 3 k/m
Sweep block	Center frequency 836 MHz	Press Center 836 (M/µ)
	Span frequency 200 MHz	Press (Span) 200 (M/µ)

Performing Calibration

Perform a frequency response calibration for this measurement as follows:

1. Press Cal CALIBRATE MENU RESPONSE.

- 2. Connect a THRU calibration standard between the measurement cables in place of the DUT.
- 3. Press THRU to perform a frequency response calibration data measurement.
- 4. Press DONE: RESPONSE. (CORRECTION on OFF is automatically set to CORRECTION ON off.)

Measurement

Replace the THRU standard with the DUT. Press (Scale Ref) AUTO SCALE if the trace needs to be rescaled. Note that the display shows the complete response of the bandpass filter under test.

Read Out Insertion Loss Using the Marker

- 1. Press (Search) MAX to move the marker to the maximum value of trace. The marker reads out the insertion loss and displays it at the upper right of the display.
- 2. Press (Marker) ΔMARKER MENU ΔMKR to turn on the ΔMarker (at the position of the marker).
- 3. Enter 60 M/μ to move the marker to the point offset from the Amarker. The Amarker value shows the out-of-band rejection.

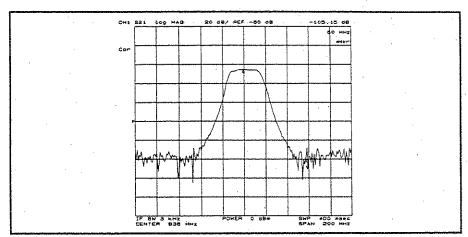


Figure 4-2. Response of a Dielectric Filter

3 dB Bandwidth

The analyzer calculates the bandwidth of the DUT between two equal power levels. In this example, it calculates the -3 dB bandwidth relative to the filter center frequency.

- 1. Press Marker. Then use the rotary knob to move the marker to the center of the filter passband.
- 2. Press Search WIDTH [OFF] WIDTH on OFF to ON off. The analyzer calculates the -3 dB bandwidth, center frequency, Q (Quality Factor), insertion loss, and differences between the center frequency and the cutoff frequencies of the DUT. It then lists the results at the upper right hand of the display. Sub-marker 1 on the trace shows the passband center frequency and sub-markers 2 and 3 show the location of the -3 dB cutoff points.

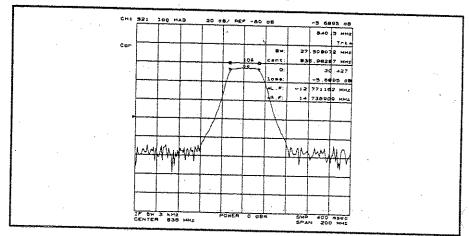


Figure 4-3. Using the Marker to Determine 3 dB Bandwidth

To have the analyzer calculate the bandwidth between other power levels, select WIDTH VALUE and enter the number (for example, enter -6×1 for -6 dB).

Press Marker PRESET MKRS when you are finished with this measurement.

Ripple or Flatness

Passband ripple (or flatness) is the variation in insertion loss over a specified portion of the passband.

- 1. Press Display DUAL CHAN on OFF to ON off to display channel 2 below channel 1.
- 2. Press (Sweep) COUPLED CH ON off to on OFF.
- 3. Press (Search) MAX.
- 4. Press (Marker --) CROSS CHAN on OFF to ON off.
- 5. Press MORE ZOOMING APERTURE 20 (X1) RETURN MKR ZOOM.
- 6. Press (Ch 2) (Search) MAX. Then press (Scale Ref) MKR-REFERENCE SCALE/DEV 0.5×10^{-5} to magnify the trace to resolve the ripple.
- 7. Press (Search) SEARCH: PEAK. Then press (Marker) AMODE MENU AMKR.
- 8. Press (Search) SEARCH: PEAK PEAK DEF MENU PEAK PLRTY POS neg to pos NEG RETURN. Then press SEARCH: PEAK. The passband ripple is automatically given as the peak-to-peak variation between the markers. The ripple value is displayed at the upper right of the display.

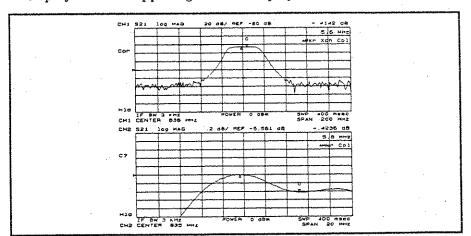


Figure 4-4. Using Peak Search to Determine Ripple

Press (Ch 1) (Marker) PRESET MKRS, and (Ch 2) (Marker) PRESET MKRS when you are finished with this measurement.

Measuring Phase Response

A two input ratio measurement can also provide information about the phase shift of a network. The analyzer can translate this information into a related parameter, group delay.

With the same connection, instrument settings, and calibration used in the previous example (see "Measurement Setup" in "Measuring Transmission Characteristics of a Filter"), make the following changes:

- 1. Press Ch 1 (Sweep) COUPLED CH on OFF to ON off to couple sweep parameters of channel 2 to channel 1.
- 2. Press Ch 2 Format PHASE to display the phase response on channel 2.

If the trace needs to be rescaled, press Scale Ref and AUTO SCALE.

Figure 4-5 shows the phase response of the bandpass filter. Notice the linear phase shift through the passband and the rapid fluctuations that occur outside this region. The random phase of the broadband noise floor causes the spurious out-of-band response.

This format displays phase over the range of -180 to +180 degrees. As phase increases beyond these values, a sharp 360 degree transition occurs in the display as the trace "wraps" between +180 and -180 degrees. This wrap causes the characteristic "sawtooth" display usually seen on devices with linearly increasing (or decreasing) phase responses.

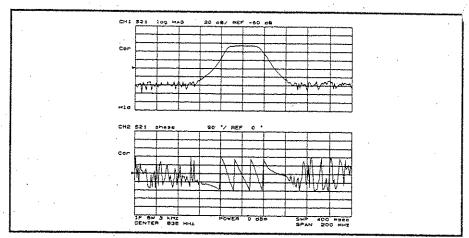


Figure 4-5. Amplitude and Phase Response of a Dielectric Filter

Using the Expanded Phase Mode

The analyzer can display phase beyond ± 180 degrees. Press (Format MORE EXPANDED PHASE. Then press (Scale Ref) AUTO SCALE. The phase is displayed with "no wrap" (see Figure 4-6).

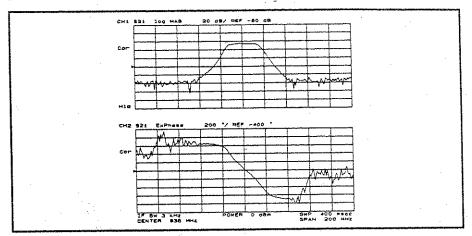


Figure 4-6. Expanded Phase Mode

Press (Format) PHASE when you are finished with this measurement.

Measuring Electrical Length

The analyzer electronically implements a function similar to the mechanical "line stretchers" of earlier analyzers. The analyzer's electrical length correction function simulates a variable length lossless transmission line. This simulated line can be added or removed from a receiver's input to compensate for interconnecting cables or other connections. In this example, this function is used to measure the electrical length of a test device.

Measurement Setup

With the same connection, instrument settings, and calibration used in the previous example (see "Measurement Setup" in "Measuring Transmission Characteristics of a Filter"), make the following changes:

- 1. Press Ch 1 Format PHASE to display the phase trace on channel 1.
- 2. Press Display DUAL CHAN ON off to on OFF.
- 3. Press (Span) 50 (M/μ) to zoom the passband trace on the display.

Measurement

If the trace needs to be rescaled, press (Scale Ref) AUTO SCALE,

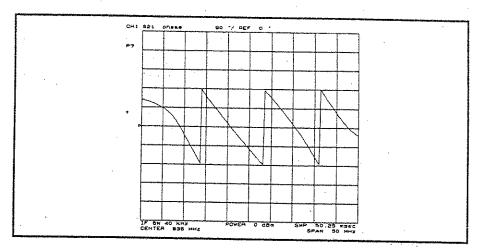


Figure 4-7.
Phase Response of a Dielectric Filter Over a 50 MHz Span

Electrical Length Adjustment

The linearly decreasing phase is due to the DUT's electrical length. This length is measured by electronically adding length to the R input to compensate for it.

- 1. Press Ch 2) to activate channel 2.
- 2. Press Marker. Then move the marker to any of the points where the sloping trace crosses the center. Place the marker on the sloping portion of the trace, not on the vertical phase "wrap-around."

- 3. Press (Scale Ref) ELEC DELAY MENU MARKER-DELAY. The analyzer adds enough electrical length to match the group delay present at the marker frequency (group delay is discussed in the next measurement example).
- 4. Press Display DUAL CHAN on OFF to ON off to display the results before and after the adjustment. The results are shown in Figure 4-8.
- 5. To display the amount of electrical length added, press (Scale Ref) ELEC DELAY MENU ELECTRICAL DELAY.

You can also determine the electrical length by pressing (Scale Ref) ELEC DELAY MENU ELECTRICAL DELAY. Then turn the rotary knob until the displayed trace is flat (see Figure 4-8). It may take many revolutions of the knob before the trace is flat.

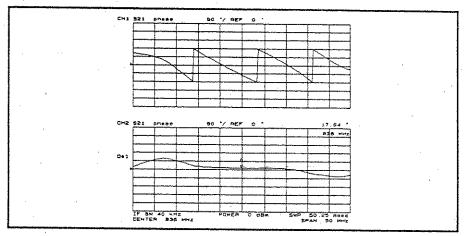


Figure 4-8. Electrical Length Adjustment

Measuring Phase Distortion

For many networks, the amount of insertion phase is not nearly as important as the linearity of the phase shift over a range of frequencies. The analyzer can measure this linearity and express it in two different ways:

- Directly (as deviation from linear phase).
- As group delay (a derived value).

Measurement Setup

This example assumes the measurement settings made in "Measuring Electrical Length" (the previous example) are still in effect.

Deviation from Linear Phase

By adding electrical length required to flatten the phase response, you have already removed the linear phase shift caused by the DUT. The remaining response is the deviation from linear phase.

Press Display DUAL CHAN ON off to on OFF.

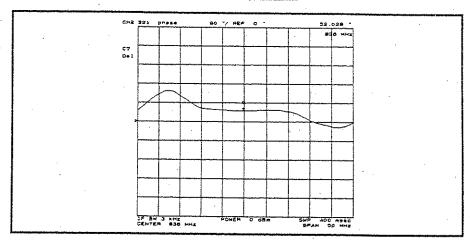


Figure 4-9. Deviation From Linear Phase

Press Scale Ref ELEC DELAY MENU ELECTRICAL DELAY 0×1 when you are finished with this measurement.

Group Delay Measurement

The phase linearity of many devices is specified in terms of group delay or envelope delay. This is especially true of telecommunications components and systems.

Group delay is the difference in propagation time through a device as a function of frequency. It is measured as a ratio of phase change over a sample delta frequency as follows:

Group Delay =
$$-\frac{\Delta\phi}{360\Delta F}$$

Where:

 $\Delta \phi$ is phase change [deg]

 ΔF (commonly called the "aperture") is the frequency difference that gives $\Delta \phi$

To display group delay, press Format DELAY. If the trace needs to be rescaled, press Scale Ref and AUTO SCALE. The default aperture is very narrow, so the group delay measurement displayed is very noisy.

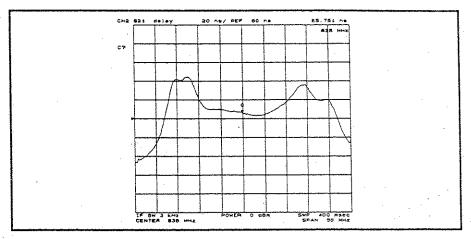


Figure 4-10. Group Delay

Smoothing Group Delay Trace

By setting a wide aperture, rapid changes in phase are averaged and have less affect on the measurement. However, some loss in measurement detail occurs with wide apertures. Press Bw/Avg GROUP DELAY APERTURE. The value of the aperture is shown at the upper left of the display. Press to increase the aperture (the display becomes less noisy).

Where to Find More Information

For more information on group delay principles, see the *Task* Reference manual.

Reflection Measurement

When making a reflection measurement, the analyzer monitors the signal going to the DUT and uses it as the reference. It compares the reflected signal from the DUT to the reference signal. The ratio of the incident and reflected signals is the reflection coefficient of the DUT or, when expressed in decibels, the return loss.

Reflection measurements require the connection of a directional device, such as a directional coupler, to separate the power reflected from the DUT. This separation is necessary so that it can be measured independently of the incident power (see the following figure).

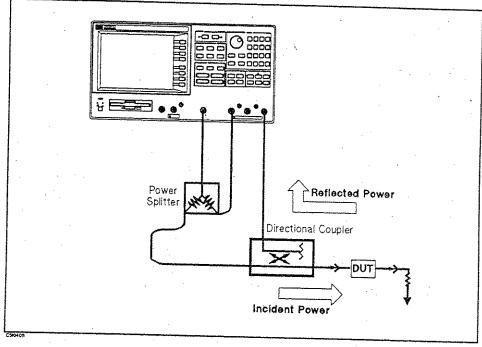


Figure 4-11. Reflection Measurement

Multi-Port Test Devices

When the device has more than one port, connect high-quality terminations (loads) to all unused DUT ports to terminate them into their characteristic impedance (usually 50 or 75 Ω). If this is not done, reflections off the unused ports will cause measurement errors.

The S-parameter test set automatically switches the termination at the unused port for each S-parameter measurement. When using a transmission/reflection test set, terminate the unused input port of the analyzer with a high quality load.

The signal reflected from the DUT is measured as a ratio with the incident signal. It can be expressed as a reflection coefficient, a return loss, or as SWR. These measurements are mathematically defined as:

= ρ (magnitude only)

 $= \Gamma$ (magnitude and phase)

= S₁₁ or S₂₂ (magnitude and phase)

$$SWR = \frac{1 + \rho}{1 - \rho}$$

Measurement Setup

Connection

Set up the analyzer as shown in Figure 4-12.

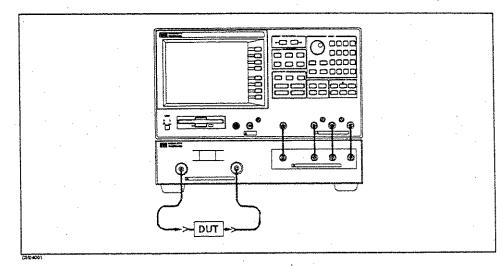


Figure 4-12. Reflection Measurement Setup

Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Setting	Key Strokes
Active Channel Block	Select channel 1	Press Ch 1 (default)
Measurement	Select network analyzer	Press Meas ANALYZER TYPE NETWORK ANALYZER
Block	Select S ₁₁	Press Meas Refl:FWD Sii [A/R] (default)
	Select LOG MAG format	Press Format LOG MAG (default)
Sweep block	Center frequency 836 MHz	Press Center 836 M/µ
	Span frequency 100 MHz	Press Span 100 M/µ

Performing Calibration

Perform an S_{11} , 1-port calibration for this measurement. The following procedure is for using 7 mm standards (see the TaskReference manual for using other standard devices).

- 1. Press Cal CALIBRATE MENU S11 1-PORT.
- 2. Connect the OPEN standard to port 1. Then press (S11):OPEN. (The softkey label OPEN is underlined when the measurement is completed.)
- 3. Connect the SHORT standard to port 1. Then press SHORT. (The softkey label SHORT is underlined when the measurement is completed.)
- 4. Connect the LOAD standard to port 1. Then press LOAD. (The softkey label LOAD is underlined when the measurement is completed.)
- 5. Press DONE: 1-PORT CAL. (CORRECTION on OFF is automatically set to ON off.)

Note



The next example "S-Parameters Measurement" uses the calibration corrections you just completed. Do not change the calibration settings before doing the example.

Measurement

Connect the DUT to the test set. Press Scale Ref AUTO SCALE if the trace needs to be rescaled.

Return Loss and Reflection Coefficient

The return loss characteristics are displayed in the Log Mag format in Figure 4-13. The value inside the passband is greater than outside the passband. A large value for return loss corresponds to a small reflected signal just as a large value for insertion loss corresponds to a small transmitted signal.

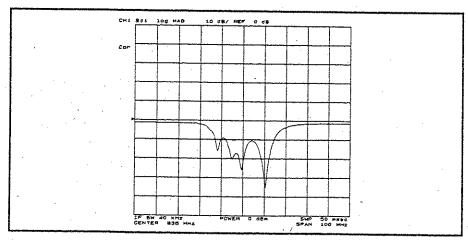


Figure 4-13. Return Loss

To display the same data in terms of reflection coefficient, press

[Format] LIN MAG. This redisplays the existing measurement in a linear

magnitude format that varies from $\Gamma = 1.00$ at the top of the display (100% reflection) to 0.00 at the bottom of the display (perfect match).

Standing Wave Ratio

To display the reflection measurement data as standing wave ratio (SWR), press Format SWR. The analyzer reformats the display in the unitless measure of SWR (with SWR = 1, a perfect match, at the bottom of the display).

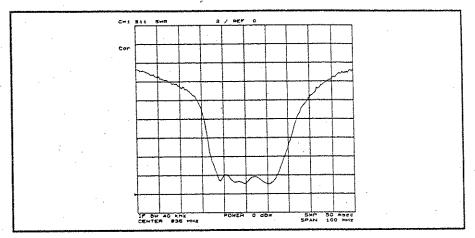


Figure 4-14. SWR

S-Parameters Measurement

S-parameters S_{11} and S_{22} are no different from the measurements made in the previous section. S_{11} is the complex reflection coefficient of the DUT's input. S22 is the complex reflection coefficient of the DUT's output. In both cases, all unused ports must be properly terminated.

To display the trace on the polar chart, press Format POLAR.

The results of a typical S₁₁ measurement is shown in Figure 4-15. Each point on the polar trace corresponds to a particular value of both magnitude and phase.

Polar Chart Shows Magnitude and Phase

- Magnitude
 - \Box The center of the circle represents a reflection coefficient Γ of 0, that is, a perfect match or no reflected signal.
 - \Box The outermost circumference of the scale represents a Γ = 1.00, or 100 % reflection.
- Phase
 - ☐ The 3 o'clock position corresponds to zero phase angle, that is, the reflected signal is at the same phase as the incident signal.
 - \square Phase differences of 90, 180, and 270 degrees correspond to the 12, 9, and 6 o'clock positions on the polar display, respectively.

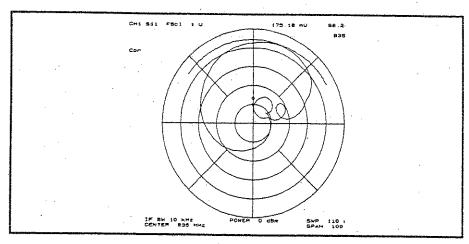


Figure 4-15. S₁₁ on Polar Chart

Data Readout Using the Marker

Press (Marker) and use the knob to position the marker at any desired point on the trace. Then read the frequency, magnitude, and phase in the upper right hand corner of the display. Or, enter the frequency of interest from the data entry key pad to read the magnitude and phase at that point.

To read the marker data in logarithmic, linear, real/imaginary. impedance (R+jX), admittance (G+jB), or SWR/phase formats, press (Utility) SMTH/POLAR MENU and select the desired format.

Impedance Measurement

The amount of power reflection from a device is directly related to the impedance values of both the device and the measuring system. In fact, each value of the reflection coefficient (Γ) uniquely defines a device impedance. For example:

- Γ =0 occurs when the device and test set impedance are the same.
- **a** A short circuit has a reflection coefficient of $\Gamma = 1 \angle 180^{\circ} (=-1)$.
- An open circuit has a reflection coefficient of $\Gamma=1$ $\angle 0$ ° (=1).

Every other value for Γ also corresponds uniquely to a complex device impedance, according to the equation

$$Zn=\frac{1+\Gamma}{1-\Gamma}$$

Where Zn is the DUT impedance normalized to (that is, divided by) the measuring system's characteristic impedance (usually 50 or 75 Ω). The network analyzer has a default impedance of 50 Ω . To set the impedance to 75 Ω , press (a) MORE SET ZO. The network analyzer uses the formula above to convert the reflection coefficient measurement data to impedance data.

- 1. Press (Format) SMITH. The display shows the complex impedance of the DUT over the frequency range selected.
- 2. Press Marker to turn on the marker. Then use the knob to read the resistive and reactive components of the complex impedance at any point along the trace. The maker displays a complex impedance readout.

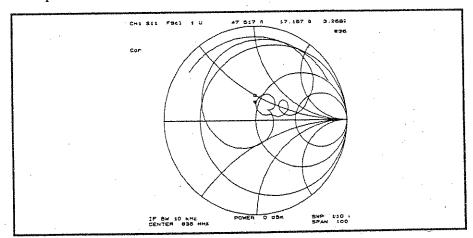


Figure 4-16. Impedance Measurement

Admittance Measurement

- 1. Press Format MORE ADMITTANCE CHART. The display shows the complex impedance of the DUT over the frequency range selected.
- 2. Use the knob to read the resistive and reactive components of the complex impedance at any point along the trace. The maker displays complex impedance readout.

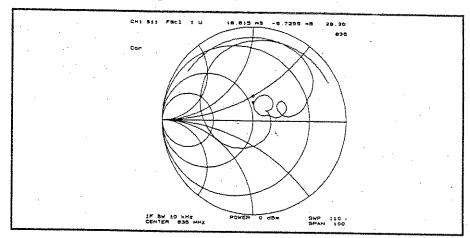


Figure 4-17. Admittance Measurement

List Sweep

The analyzer has a list sweep function that can sweep frequency according to a predefined sweep segment list. Each sweep segment is independent. For the network analyzer mode, each segment can have a different number of sweep points, power level, and IF bandwidth value. For the spectrum analyzer mode, each segment can have a different number of points and RBW.

A segment looks like a normal sweep setting. The list sweep function can combine up to 31 segments settings into 1 sweep. The analyzer can have two different sweep lists. One list for the network analyzer and the other list for the spectrum analyzer. When both channels are set to the same analyzer mode, both channels use the same list. This example describes the following two applications:

- Sweep time reduction for filter testing in the network analyzer mode (including the setup procedure).
- Dynamic range enhancement in the network analyzer mode.

Sweep Time Reduction

The following example creates a list sweep to measure a filter that has a 836 MHz center frequency and a 50 MHz bandwidth. This example uses the list sweep to reduce the sweep time by setting coarse sweep points for the rejection band and the fine sweep points for the passband.

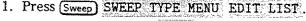
Analyzer Settings

Press (Preset). Then set the analyzer's controls as follows:

	Desired Setting	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement	Select Network Analyzer	Press Meas ANALYZER TYPE NETWORK ANALYZER
Block	Select S ₂₁ (or B/R) measurement	Press Meas Trans:FWD S21 [B/R]
	Select LOG MAG format	Format FORMAT: LOG MAG (default)

Creating a Sweep List

Perform the following procedure to create a list (see the graph below):



- 2. To edit the list, press EDIT.
- 3. For segment 1:

Press (Start) 736 (M/ μ).

Press Stop 796 M/μ .

Press NUMBER of POINTS 30 (X1) SEGMENT DONE.

4. For segment 2:

Press ADD.

Press (Stop) 876 (M/ μ).

Press NUMBER of POINTS 120 (X1) SEGMENT DONE.

5. For segment 3:

Press ADD.

Press (Stop) 936 M/μ).

Press NUMBER of POINTS 30 X1 SEGMENT DONE

6. Press LIST DONE.

The segments do not have to be entered in any particular order. The analyzer automatically sorts them in increasing order of sweep parameter value.

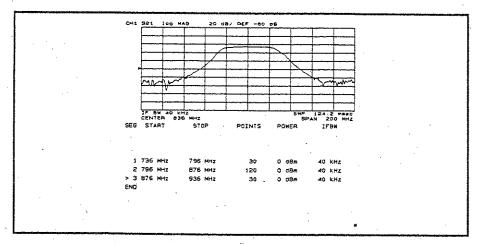


Figure 4-18. Sweep List Edit Display

Performing List Sweep

Press Sweep SWEEP TYPE MENU LIST FREQ to perform the list sweep measurement.

736MHz

30 points

Segment 1

796MHz

Seament 2

876MHz

936MHz

Segment 3

Dynamic Range Enhancement

Figure 4-19 shows the sweep list modified from the list of the previous example to improve dynamic range. Segments 1 and 2 have a narrow IF bandwidth and a higher power level for the stopband of the filter. Segment 3 has a wide IF bandwidth and lower power level for passband.

- 1. Press Sweep SWEEP TYPE MENU EDIT LIST.
- 2. To modify segment 1, press SEGMENT 1×1 EDIT.
- 3. Press POWER 15 (X1) IFBW 10 (X1) SEGMENT DONE.
- 4. To modify segments 2 and 3, see Figure 4-19 for the values and modify them in a manner similar to steps 2 and 3.
- 5. Press LIST DONE.

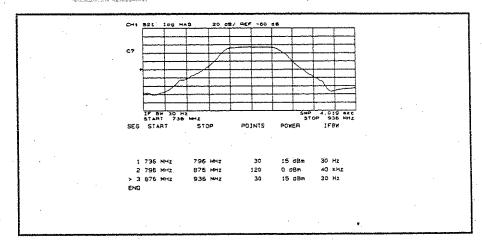


Figure 4-19. Dynamic Range Enhancement

The Save key can save sweep lists along with all other current instrument settings (see the Task Reference).

Filter Testing Using Limit Lines

The analyzer has limit line/testing functions for go/no-go testing. The limit lines define upper and lower limits. The limit testing functions compare the measured data to the limit lines and indicate the result. The following example is a practical method for setting up limit lines to test a bandpass filter.

Example of Limit Lines For Filter Testing

This example creates limit lines to test a 70 MHz crystal bandpass filter.

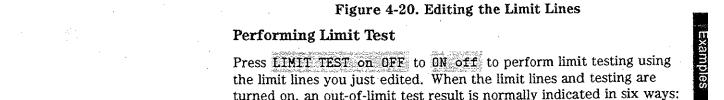
Analyzer Settings

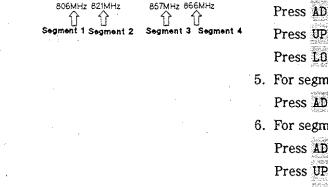
Press Preset. Then set the analyzer's controls as follows:

·	Desired Setting	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement Block	Select S ₂₁ (or B/R) measurement Select LOG MAG format	Press Meas Trans: FWD S21 [B/R] Format LOG MAG (default)
Sweep Block	Center frequency 836 MHz	Press Center 836 M/µ
	Span frequency 100 MHz Number of points 401	Press (Span) 100 (M/µ) Press (MENU) NUMBER of POINTS 401 (x1)

Creating Limit Lines

Perform the following procedure (see Figure 4-20):





- 1. Press (System) LIMIT MENU LIMIT LINE on OFF to ON off.
- 2. Press EDIT LIMIT LINE EDIT.
- 3. For segment 1:

Press SWP PARAM VALUE 806 M/μ .

Press UPPER LIMIT -55×1 .

Press LOWER LIMIT -120 (X1) DONE.

4. For segment 2:

Press ADD SWP PARAM 821 (M/μ) .

Press UPPER LIMIT -1×1 .

Press LOWER LIMIT -15×1 DONE.

5. For segment 3:

Press ADD SWP PARAM 851 (M/μ) DONE.

6. For segment 4:

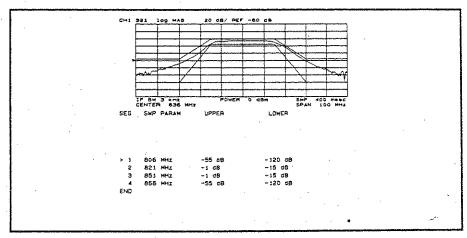
Press ADD SWP PARAM 866 (M/μ).

Press UPPER LIMIT -55×1 .

Press LOWER LIMIT -120 (X1) DONE.

7. Press DONE.

The limit line segments do not have to be entered in any particular order. The analyzer automatically sorts them and lists them on the display in the increasing order of sweep parameter value.



turned on, an out-of-limit test result is normally indicated in six ways:

- With a FAIL message on the screen.
- With a beep (on/off selectable).
- With an asterisk in tabular listings of data (under Copy).
- With a bit in HP-IB event status register B.

- w With a bit in the I/O port on the rear panel.
- w With the HP-IB commands OUTPLIMF?, OUTPLIMIL?, and OUTPLIMM?.

Separated Limit Lines

Figure 4-21 shows separated limit lines and an editing table example. This example can be used for filter testing that only requires insertion loss limits. Dummy limit values (+5000 for upper and -5000 for lower, for example) should be entered for the no limit areas.

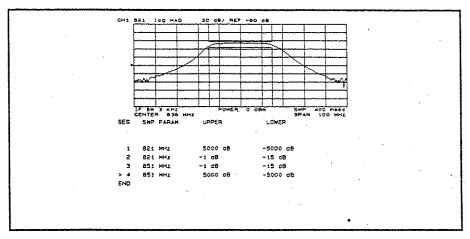


Figure 4-21. Separated Limit Lines

- Limits are only checked at each of the actual measured data points. It is possible for a device to be out of specification without a limit test failure indication if you do not select sufficient sweep parameter points within a segment.
- By combining the limit test and the list sweep function, high throughput limit line/testing can be performed for go/no-go testing. For detailed information on the list sweep, see "List Sweep" in this chapter.
- Limit line information is lost if you press (Preset) or turn off the power. However, the (Save) keys can save the limit line information along with all other current instrument settings when the limit lines are on. See the Task Reference manual for details.

Gain Compression Measurement

An important measure of active circuits is how well they handle a signal frequency with a varying input amplitude. By using the power sweep function in the network analyzer mode, measurements such as gain compression or automatic gain control slope can be made.

Measurement Setup

Connection

Set up the analyzer as shown in Figure 4-22.

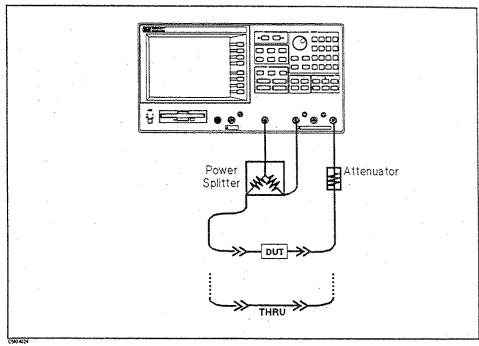


Figure 4-22. Gain Compression Measurement Setup **Analyzer Settings**

Press (Preset). Then set the analyzer's controls as follows:

	Desired Settings	Key Strokes
Active Channel Block	Select channel 1	Ch 1 (default)
Measurement block	Select Network Analyzer	Press Meas ANALYZER TYPE NETWORK ANALYZER
Same and the same	Select S ₂₁ (or B/R) measurement	Press (Meas) Trans:FWD S21 [B/R]
Married de la Contraction de l	Select LOG MAG format	Format LOG MAG (default)
	IF BW 10 kHz	(Bw/Avg) 10 k/m
Sweep block	Select power sweep	Press (Sweep) SWEEP TYPE POWER
	Start power -20 dBm	Press Start -20 X1
	Stop power 0 dBm	Press Stop 0 x1

Performance Calibration

Perform a power response calibration for this measurement as follows:

- 1. Press (Cal) CALIBRATION MENU RESPONSE.
- 2. Connect a THRU calibration standard between the measurement cables in place of the DUT (see Figure 4-22).
- 3. Press THRU to perform a power response calibration data measurement.
- 4. Press DONE: RESPONSE. (CORRECTION on OFF is automatically set to CORRECTION ON off.)

Measurement

- 5. Replace the THRU standard with the DUT.
- 6. Press Scale Ref AUTO SCALE if the trace needs to be rescaled.
- 7. Press Search MAX to move the marker to the maximum point on the trace.
- 8. Press Marker ΔMODE MENU ΔMkr to set the Δmarker to the maximum point.
- 9. Press Search TARGET -1 $\times 1$ to search for the point of the gain compression. (See Figure 4-23.)

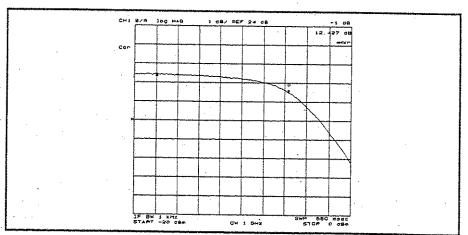


Figure 4-23. Gain Compression

Absolute Output Level Measurement

The analyzer can show the characteristics input level versus output level by using the absolute measurement capability in the network analyzer mode.

- 1. Press (Sweep) CHAN COUP on OFF to CHAN COUP ON off to couple the sweep parameters of both channels.
- 2. Press (Marker) MKR COUP on OFF to MKR COUP ON off to couple the marker between both channels.
- 3. Press Ch 2 Meas B to select the absolute measurement at the B input.
- 4. Press Display DATA MATH [DATA] OFFSET. Then input the value of the attenuator that is connected between the DUT and the B input. In this example measurement, a 30 dB attenuator is used. Therefore, enter 30×1 .
- 5. Press (Scale Ref) AUTO SCALE if the trace needs to be rescaled.
- 6. The analyzer displays the input versus output power levels. The marker shows the input and output power levels at the -1 dB gain compression point.
- 7. Press Display DUAL CHAN on OFF to ON off to display both channel (see Figure 4-24). Note that you must subtract 3 dB from the input value readout. This is necessary because the input signal is attenuated by the power splitter that is between the RF OUT and the DUT.

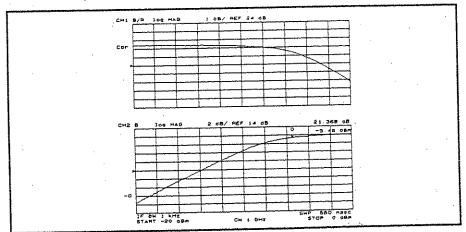


Figure 4-24. Input vs. Output Power Level at the -1 dB Gain Compression Point

Installation and Setup Guide

This appendix provides installation and setup instructions. It contains the following information:

- Incoming inspection
- Rack/Handle installation
- Power requirements
- Connecting a test set for network analyzer mode
- Connecting an active probe
- Connecting a keyboard
- $\mbox{\ensuremath{\blacksquare}}$ Setting up a 75 Ω measurement for spectrum analyzer mode

Incoming Inspection

The analyzer is carefully inspected, both electrically and mechanically, before it is shipped from the factory. It should be in perfect condition, with no scratches or no dents. Verify this by carefully performing an incoming inspection to check the instrument for signs of physical damage, missing contents. If any discrepancy is found, notify the carrier and Hewlett-Packard. Your HP sales office will arrange for repair and replacement without waiting for the claim to be settled.

- 1. Unpack the package.
- 2. Verify all items listed in Table A-1 are present.
- 3. Inspect the exterior of the analyzer for any signs of damage.
- 4. Verify that the analyzer is equipped with the options you ordered.

Table A-1. Contents

Description	HP Part Number
Network/Spectrum Analyzer	HP 4396A
Documents	
Task Reference	04396-90000
User's Guide	04396-90001
Function Reference	04396-90002
Programming Guide	04396-90003
HP-IB Command Reference	04396-90004
Performance Test Manual	04396-90100
N to BNC adapter (50 Ω)	1250-0780
BNC cable	8120-1839
Sample Program Disk (2 disks)	04396-61002
3.5inch 2HD Disk (blank)	9164-0299
Power Cable ¹	
Option 0BW only	
Service Manual	04396-90101
Option 1D5 only	
BNC Adapter	1250-1859
Option 1D7 only	
50 Ω to 75 Ω Minimum Loss Pad	HP 11825B option CO4
50 Ω BNC to 75 Ω N Adapter	1250-2438
Option 1C2 only	
Keyboard Template	08751-87111
HP-HIL Keyboard	HP 46021A
Keyboard Cable	4602-60001
HP Instrument BASIC User's HandBook	E2083-90000
Using HP Instrument BASIC with the HP 4396A	04396-90005

¹ The power cable depends on where the instrument is used, see Figure A-2.

Rack/Handle Installation

The analyzer can be rack mounted and used as a component in a measurement system. Figure A-1 shows how to rack mount the analyzer.

Table A-2. Rack Mount Kits

Option	Description	HP Part Number
1CN	Handle Kit	5062-3991
1CM	Rack Mount Kit	5062-3979
1CP	Rack Mount & Handle Kit	5062-3985

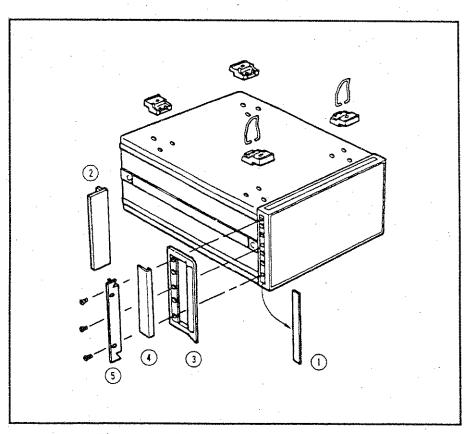


Figure A-1. Rack Mount Kits Installation

Option 1CN Handle Kit

Option 1CN is a handle kit containing a pair of handles and the necessary hardware to attach them to the instrument.

Installing the Handle

- 1. Remove the adhesive-backed trim strips ① from the left and right front sides of the analyzer.
- 2. Attach the front handles 3 to the sides using the screws provided.
- 3. Attach the trim strips 4 to the handles.

Option 1CM Rack Mount Kit

Option 1CM is a rack mount kit containing a pair of flanges and the necessary hardware to mount them to the instrument in an equipment rack with 482.6 mm (19 inches) horizontal spacing.

Mounting the Rack

- 1. Remove the adhesive-backed trim strips ① from the left and right front sides of the analyzer.
- 2. Attach the rack mount flange ② to the left and right front sides of the analyzer using the screws provided.
- 3. Remove all four feet (lift bar on the inner side of the foot, and slide the foot toward the bar).

Option 1CP Rack Mount & Handle Kit

Option 1CP is a rack mount kit containing a pair of flanges and the necessary hardware to mount them to an instrument which has handles attached, in an equipment rack with 482.6 mm (19 inches) spacing.

Mounting the Handle and Rack

- 1. Remove the adhesive-backed trim strips ① from the left and right front sides of the analyzer.
- 2. Attach the front handle ③ and the rack mount flange ⑤ together on the left and right front sides of the analyzer using the screws provided.
- 3. Remove all four feet (lift bar on the inner side of the foot, and slide the foot toward the bar).

Power Requirements

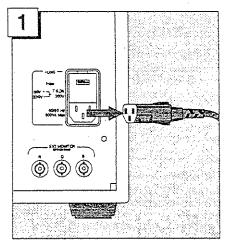
The analyzer can operate from any single phase ac power source supplying 100 V, 120 V, 220 V, and 240 V in the frequency range from 47 to 66 Hz (see Table A-3). With all options installed, the power consumption is less than 100 VA.

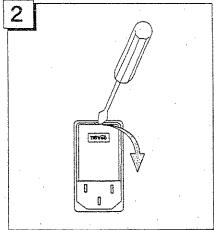
Table A-3. Line Voltage Ranges

AC Voltage Range	Selector Voltage
100/120 V	115 V
220/240 V	230 V

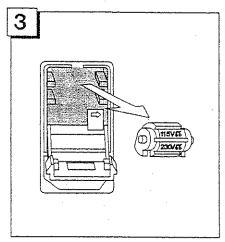
Changing the Line Voltage Setting

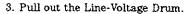
The line voltage selector is set at the factory to correspond to the most commonly used line voltage of the country of destination. The line voltage selected for the analyzer is indicated on the line voltage selector. Refer to table Table A-3 for the line voltage ranges. Perform the following steps to change the line voltage:

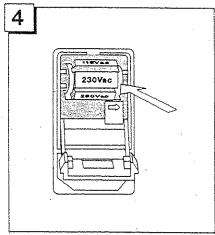




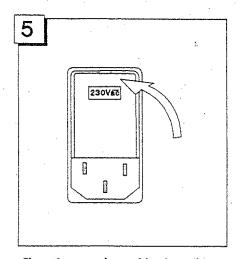
Remove the power cord if it is connected. Open the cover of AC line receptacle on the rear panel using a small, flat-blade screwdriver.







4. Insert the Line-Voltage Drum so that the required voltage is displayed at the front.



Close the cover by pushing it until it clicks. Verify that the correct line voltage appears in the window of the power selector cover.

Replacing the Fuse

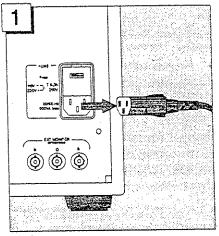
The HP part number of the fuse is 2110-0917.

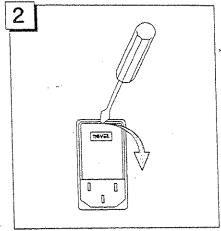
Note



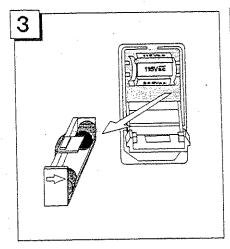
The same fuse can be used for both line voltage settings. You do not have to change the fuse when changing the line voltage.

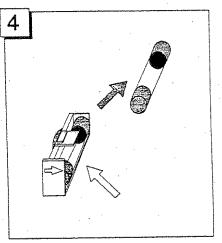
Perform the following steps to exchange the fuse.





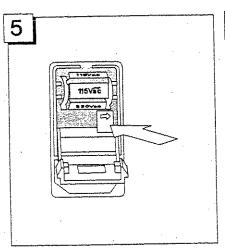
Remove the power cord if it is connected. Open the cover of AC line receptacle on the rear panel using a small, flat-blade screwdriver.



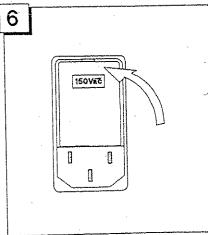


holder out of the power selector and remove the fuse from the fuse holder.

To check or replace the fuse, pull the fuse. To reinstall the fuse, insert a fuse with the proper rating into the fuse holder.



Push the fuse holder into the power selector.



Close the cover by pushing it until it clicks.

Power Cable Requirement

To protect operating personnel, the National Electric Manufacture's Association (NEMA) recommends that the instrument panel and cabinet be grounded. The analyzer is equipped with a three-conductor power cord that, when plugged into an appropriate receptacle, grounds the analyzer cabinet. The offset pin on the power cord is the safety ground.

To preserve this protection feature when operating the instrument from a two-prong outlet, use a three-prong to two-prong adapter (HP Part Number 1251-8196) and connect the green pigtail on the adapter to the power-line ground.

Figure A-2 shows the available power cords used in various countries. Also shown is the standard power cord furnished with the instrument. HP part numbers, applicable standards for power plugs, electrical characteristics, and the countries using each type of power cord are also listed in Figure A-2. For assistance in selecting the correct power cord, contact the nearest Hewlett-Packard sales office.

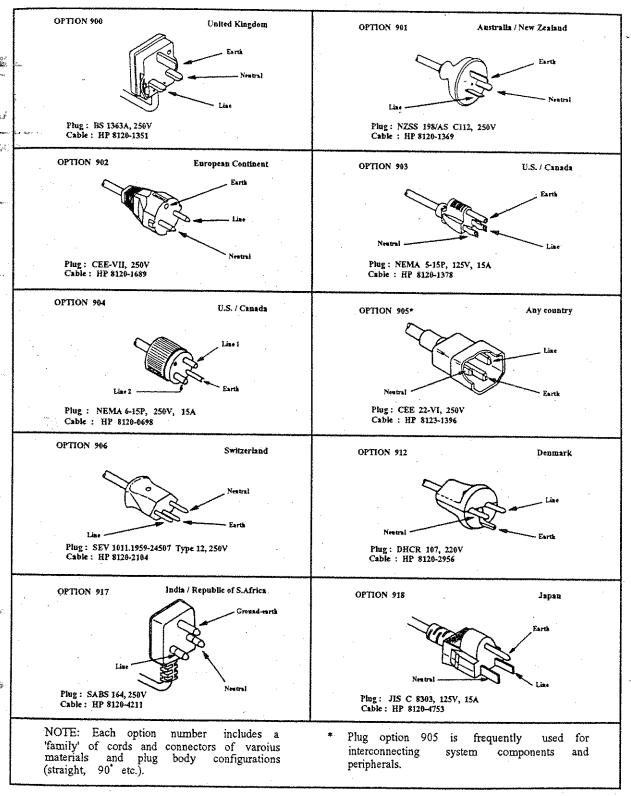


Figure A-2. Power Code Supplied

Connecting a Test Set for Network Analyzer Mode

To use the network analyzer mode of the analyzer, a test set is required to measure the transmission and reflection characteristics of the device under test (DUT).

You can use either the HP 87512A/B transmission/reflection (T/R) test set or the HP 85046A/B S-parameter test set. The HP 87512A/B T/R test set measures reflection and transmission in the forward direction only. The HP 85064A/B S-parameter test set measures both the forward and reverse directions without reconnection.

For more information about the test sets, see chapter 9 of the *Function Reference* manual.

Connecting a Transmission/Reflection Test Set

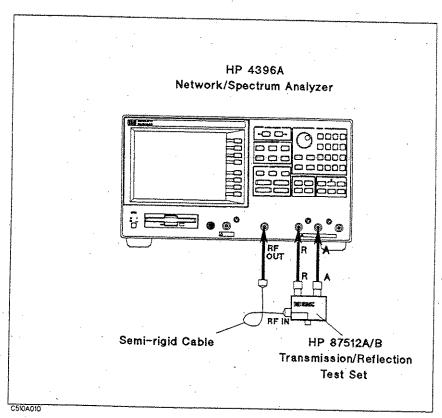


Figure A-3. Connecting a Transmission/Reflection Test Set

- 1. Place the transmission/reflection (T/R) test set in front of the analyzer.
- 2. Connect the R and A ports of the analyzer and the T/R test set to each other.
- 3. Connect the RF OUT port of the analyzer and the RF IN port of the T/R test set with a semi-rigid cable.

Note



When you use the HP 87512B, press Cal MORE SET ZO. Then press \bigcirc 5 \times 1 to set the characteristic impedance (Z₀) to 75 Ω .

Connecting an S-parameter Test Set

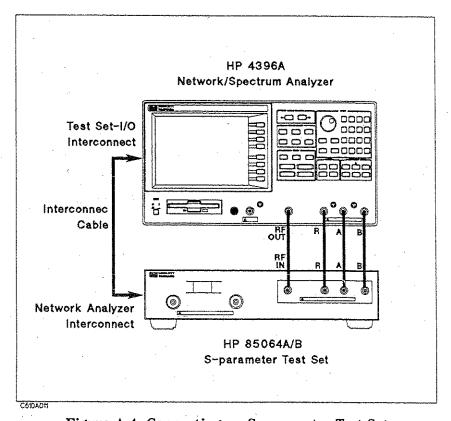


Figure A-4. Connecting an S-parameter Test Set

- 1. Place the analyzer on the S-parameter test set.
- 2. Connect the TEST SET-I/O INTERCONNECT interface on the rear panel of the analyzer and the NETWORK ANALYZER-I/O INTERCONNECT interface of the test set using the cable furnished with the test set.
- 3. Connect the RF OUT, R, A, and B inputs of the analyzer to the S-parameter test set to each other.

Note



When you use the HP 85064B, press (a) MORE SET ZO. Then press 7×1 to set the characteristic impedance (Z_0) to 75Ω .

Connecting an Active Probe

The active probe allows you to analyze an in-circuit signal or device that has no port for connecting to the test set. The active probe can be used for both spectrum and network measurements.

The analyzer can use the following active probes:

- HP 85024A High Frequency Probe (300 kHz to 3 GHz)
- HP 41800A Active Probe (5 Hz to 500 MHz)
- HP 41802A 1 MO Input Adapter (5 Hz to 100 MHz)
- HP 51701A Active Probe (DC to 2.5 GHz)
- HP 11945A Close-field Probe Set
- HP 1141A Differential Probe

For more information about these active probes, see chapter 9 of the Function Reference manual.

For Spectrum Analyzer Mode

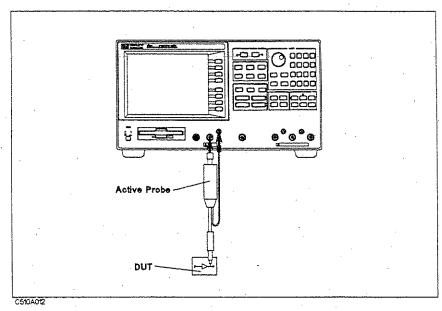


Figure A-5. Spectrum Analyzer Mode (One Active Probe)

- 1. Connect the output connector of the active probe to the S port of the analyzer.
- 2. Plug the probe power plug into the PROBE POWER connector.

For Network Analyzer Mode

Using One Active Probe

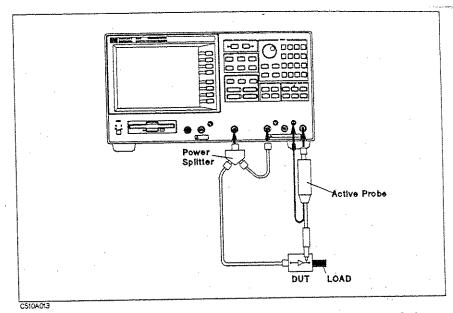


Figure A-6. Network Analyzer Mode (One Active Probe)

- 1. Connect the power splitter to the RF OUT port.
- 2. Connect one output from the power splitter to the R input.
- 3. Connect the other output of the power splitter to the DUT.
- 4. Connect the active probe to the B input and plug the probe plug into the PROBE POWER connector.
- 5. If necessary, terminate the DUT with a load.

Note



The following power splitters are available for the analyzer:

- HP 11850C,D Three-way Power Splitter
- HP 11667A Power Splitter

For more information about these power splitters, see chapter 9 of the Funtion Reference manual.

Using Two Active Probes

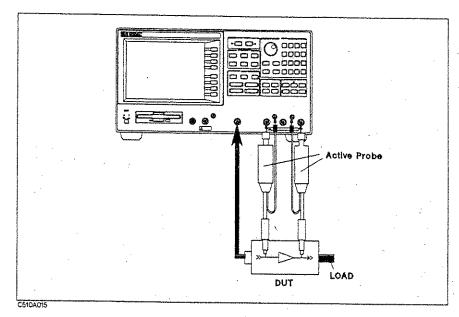


Figure A-7. Network Analyzer Mode (Two Active Probes)

- 1. Connect one active probe to the R input.
- 2. Connect the other active probe to the B input.
- 3. Connect the RF OUT port to the DUT.
- 4. If necessary, terminate the DUT with a load.

Using a Transmission/Reflection Test Set

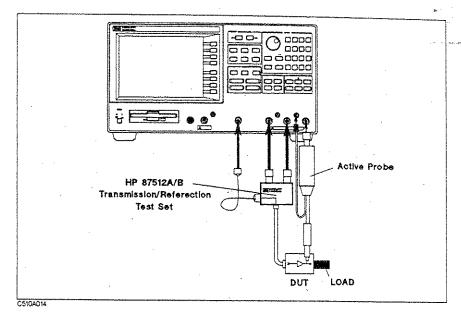


Figure A-8. Using a Transmission/Reflection Test Set

- 1. Connect the HP 87512A/B T/R test set.
- 2. Connect the active probe to the B input.
- 3. If necessary, terminate the DUT with a load.

Connecting a Keyboard

An HP-HIL keyboard can be connected to the HP-HIL connector on the rear panel of the analyzer (Option 1C2 only). The HP-HIL keyboard provides an easier way to enter characters for the file names, display titles, and Instrument BASIC programs. It can also access the analyzer softkey functions by using keyboard function keys. For more information on the HP-HIL keyboard, see *Using HP Instrument BASIC with the HP 4396A* that is included in Option 1C2.

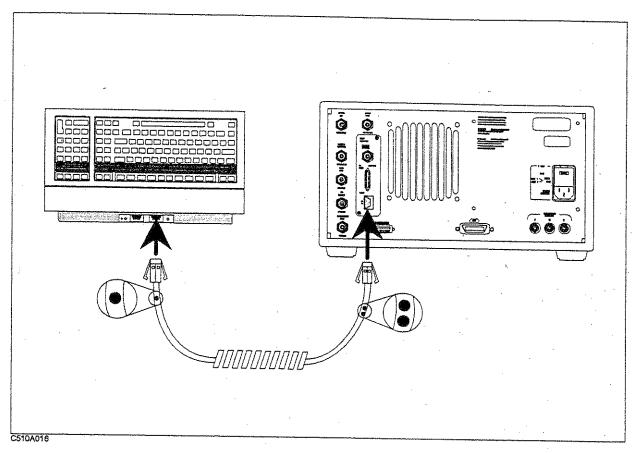


Figure A-9. Connecting a Keyboard

Setting Up a 75 Ω Measurement For Spectrum Analyzer Mode

Note



This operation requires the option 1D7500 to 750 Input Impedance Conversion. For detail information about option 1D7, see chapter 9 of the *Function Reference* manual.

- 1. Attach the HP 11852B Option C04 50 $\Omega N(m)/75~\Omega~N(f)$ minimum loss pad to the S input. This minimum loss pad is furnished with the option 1D7.
- 2. Press (Cal).
- 3. Press INPUT Z.
- 4. Press \bigcirc to set the impedance of the source (75 Ω). Then press \bigcirc Entry \bigcirc Off).

Note



Perform this procedure each time the analyzer is preset because the analyzer does not retain this setting in memory.

For More Information

The User's Guide provides an overview of the analyzer and typical applications using the analyzer. You may need or want more information on the analyzer's features. The following table shows you where to find that information:

Calibration	
How to perform calibration for the network analyzer mode	Chapter 4 in the Task Reference.
How to perform level calibration for the	Chapter 2 in the Task Reference
spectrum analyzer mode Softkey reference	Chantan Sin the Thurst Dis
Principles of calibration	Chapter 5 in the Function Reference.
	Chapter 12 in the Function Reference.
Disk and Memory How to use disk and memory storage	Chantes Cin the W. I. D. C.
Softkey reference	Chapter 6 in the Task Reference.
File system information	Chapter 8 in the Function Reference. Appendix C in the Function Reference.
	Appendix C in the Function Rejerence.
Print and Plotting	
How to print and plot Softkey descriptions	Chapter 6 in the Task Reference.
, -	Chapter 8 in the Function Reference.
Printer and plotter available	Chapter 9 in the Function Reference.
Controlling by HP-IB	
How to control the analyzer by HP-IB	See HP-IB Programming Guide
HP-IB command reference	See HP-IB Command Reference.
SCPI command reference	See HP-IB Command Reference.
Instrument BASIC (option 1C2 only)	
How to use HP Instrument BASIC	See Using HP Instrument BASIC with the
TIP I	HP 4296A furnished with option 1C2.
HP Instrument BASIC command	See HP Instrument BASIC Users Handbook
	furnished with option 1C2.
Specifications	Chapter 10 in the Function Reference.
Accessories	
How to connect	Appendix A in this guide.
Optional accessories available	Chapter 9 in the Function Reference.
Furnished accessories	Chapter 10 in the Function Reference.
Default Setting	Appendix D in the Function Reference.
Measurement Basic	Chapter 12 in the Function Reference.
Error Messages	See Messages in the Function Reference.
I/O port	
wo port	01 - 4 - 10 1 - 42 - To
How to use	Chapter 10 in the Programming Guide.
1	Chapter 10 in the Programming Guide. Chapter 12 in the Function Reference.
How to use	
How to use Descriptions	

You can also use the Table of Contents and the Index of each manual to find the specific information you need.

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